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Report No.: SZEM171001110305

Page: 1 of 72

FCC REPORT

Application No.: SZEM1710011103RG

Applicant: Saygus

Manufacturer: Saygus

Factory: Smart Gadgets (Shenzhen) , LTD

Product Name: Saygus smartphone V-Squared

Model No.(EUT): SG02

Trade Mark: Saygus

FCC ID: 2ANBZ-F10104216

Standards: 47 CFR Part 15, Subpart C (2017)

Test Method ANSI C63.10 (2013)

Date of Receipt: 2017-12-08

Date of Test: 2017-12-09 to 2017-12-29

Date of Issue: 2018-01-04

Test Result:	PASS *
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* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:

Derek Yang

Wireless Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

Report No.: SZEM171001110305

Page: 2 of 72

2 Version

Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2018-01-04		Original

Authorized for issue by:			
Tested By		 (Mike Hu) /Project Engineer	2017-12-29
Checked By		 (Jim Huang) /Reviewer	2018-01-04
			Date

3 Test Summary

Test Item	Test Requirement	Test method	Result
Antenna Requirement	47 CFR Part 15, Subpart C Section 15.203/15.247 (c)	ANSI C63.10 (2013)	PASS
AC Power Line Conducted Emission	47 CFR Part 15, Subpart C Section 15.207	ANSI C63.10 (2013)	PASS
Conducted Peak Output Power	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS
20dB Occupied Bandwidth	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS
Carrier Frequencies Separation	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS
Hopping Channel Number	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS
Dwell Time	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS
Band-edge for RF Conducted Emissions	47 CFR Part 15, Subpart C Section 15.247(d)	ANSI C63.10 (2013)	PASS
RF Conducted Spurious Emissions	47 CFR Part 15, Subpart C Section 15.247(d)	ANSI C63.10 (2013)	PASS
Radiated Spurious emissions	47 CFR Part 15, Subpart C Section 15.205/15.209	ANSI C63.10 (2013)	PASS
Restricted bands around fundamental frequency (Radiated Emission)	47 CFR Part 15, Subpart C Section 15.205/15.209	ANSI C63.10 (2013)	PASS

Original model No. in report SZEM170400351903

According to the declaration from the applicant. Now add LTE band 5,7,13,17,25,38,41, WCDMA band 5 and 2.4Gwifi and NFC by software. New function is full tested. Worse case mode of transmitter Emission above 1GHz and all mode of retested Radiated Spurious Emission on new sample are tested.

4 Contents

	Page
1 COVER PAGE	1
2 VERSION	2
3 TEST SUMMARY	3
4 CONTENTS	4
5 GENERAL INFORMATION	5
5.1 CLIENT INFORMATION	5
5.2 GENERAL DESCRIPTION OF EUT	5
5.3 TEST ENVIRONMENT	7
5.4 DESCRIPTION OF SUPPORT UNITS	7
5.5 TEST LOCATION	7
5.6 TEST FACILITY	7
5.7 DEVIATION FROM STANDARDS	7
5.8 ABNORMALITIES FROM STANDARD CONDITIONS	8
5.9 OTHER INFORMATION REQUESTED BY THE CUSTOMER	8
5.10 MEASUREMENT UNCERTAINTY (95% CONFIDENCE LEVELS, K=2)	8
5.11 EQUIPMENT LIST	9
6 TEST RESULTS AND MEASUREMENT DATA	12
6.1 ANTENNA REQUIREMENT	12
6.2 CONDUCTED EMISSIONS	13
6.3 CONDUCTED PEAK OUTPUT POWER	17
6.4 20dB OCCUPY BANDWIDTH	24
6.5 CARRIER FREQUENCIES SEPARATION	30
6.6 HOPPING CHANNEL NUMBER	34
6.7 DWELL TIME	37
6.8 BAND-EDGE FOR RF CONDUCTED EMISSIONS	48
6.9 SPURIOUS RF CONDUCTED EMISSIONS	55
6.10 RADIATED SPURIOUS EMISSION	61
6.10.1 Radiated Emission below 1GHz.....	64
6.10.2 Transmitter Emission above 1GHz.....	66
6.11 RESTRICTED BANDS AROUND FUNDAMENTAL FREQUENCY	68
7 PHOTOGRAPHS - EUT CONSTRUCTIONAL DETAILS	72



5 General Information

5.1 Client Information

Applicant:	Saygus
Address of Applicant:	10421 South Jordan Gateway, Suite 500, South Jordan, UT 84095
Manufacturer:	Saygus
Address of Manufacturer:	10421 South Jordan Gateway, Suite 500, South Jordan, UT 84095
Factory:	Smart Gadgets (Shenzhen) , LTD
Address of Factory:	912 Building 1 A, Hezheng-Huiyi Cheng, Xinhu Road, Xixiang Baoan District, Shenzhen, China

5.2 General Description of EUT

Product Name:	Saygus smartphone V-Squared
Model No.:	SG02
Trade Mark:	Saygus
Operation Frequency:	2402MHz~2480MHz
Bluetooth Version:	V4.0 Dual mode
Modulation Technique:	Frequency Hopping Spread Spectrum(FHSS)
Modulation Type:	GFSK, π/4DQPSK, 8DPSK
Number of Channel:	79
Hopping Channel Type:	Adaptive Frequency Hopping systems
Sample Type:	Portable production
Antenna Type:	Intergal
Antenna Gain:	-1.0dBi
Power Supply	DC3.85V (1 x 3.85V Rechargeable battery)3100mAh Battery: Charge by DC 5V
AC adaptor:	Adaptor: Model:C0043 Input: AC100-240V 50/60Hz 0.5A Output:DC5.0V 2.4A



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

Report No.: SZEM171001110305

Page: 6 of 72

Operation Frequency each of channel							
Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
0	2402MHz	20	2422MHz	40	2442MHz	60	2462MHz
1	2403MHz	21	2423MHz	41	2443MHz	61	2463MHz
2	2404MHz	22	2424MHz	42	2444MHz	62	2464MHz
3	2405MHz	23	2425MHz	43	2445MHz	63	2465MHz
4	2406MHz	24	2426MHz	44	2446MHz	64	2466MHz
5	2407MHz	25	2427MHz	45	2447MHz	65	2467MHz
6	2408MHz	26	2428MHz	46	2448MHz	66	2468MHz
7	2409MHz	27	2429MHz	47	2449MHz	67	2469MHz
8	2410MHz	28	2430MHz	48	2450MHz	68	2470MHz
9	2411MHz	29	2431MHz	49	2451MHz	69	2471MHz
10	2412MHz	30	2432MHz	50	2452MHz	70	2472MHz
11	2413MHz	31	2433MHz	51	2453MHz	71	2473MHz
12	2414MHz	32	2434MHz	52	2454MHz	72	2474MHz
13	2415MHz	33	2435MHz	53	2455MHz	73	2475MHz
14	2416MHz	34	2436MHz	54	2456MHz	74	2476MHz
15	2417MHz	35	2437MHz	55	2457MHz	75	2477MHz
16	2418MHz	36	2438MHz	56	2458MHz	76	2478MHz
17	2419MHz	37	2439MHz	57	2459MHz	77	2479MHz
18	2420MHz	38	2440MHz	58	2460MHz	78	2480MHz
19	2421MHz	39	2441MHz	59	2461MHz		

Note:

In section 15.31(m), regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

Channel	Frequency
The Lowest channel	2402MHz
The Middle channel	2441MHz
The Highest channel	2480MHz

5.3 Test Environment

Operating Environment	
Temperature:	24.0 °C
Humidity:	55 % RH
Atmospheric Pressure:	1005 mbar

5.4 Description of Support Units

The EUT has been tested independent unit.

5.5 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China.

518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

5.6 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC

Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

- VCCI**

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

- FCC –Designation Number: CN1178**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

- Industry Canada (IC)**

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

5.7 Deviation from Standards

None.

5.8 Abnormalities from Standard Conditions

None.

5.9 Other Information Requested by the Customer

None.

5.10 Measurement Uncertainty (95% confidence levels, k=2)

No.	Item	Measurement Uncertainty
1	Total RF power, conducted	0.75dB
2	RF power density, conducted	2.84dB
3	Spurious emissions, conducted	0.75dB
4	Radiated Spurious emission test	4.5dB (30MHz-1GHz)
		4.8dB (1GHz-25GHz)
5	Conduct emission test	3.12 dB(9KHz- 30MHz)
6	Temperature test	1°C
7	Humidity test	3%
8	DC and low frequency voltages	0.5%



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

Report No.: SZEM171001110305

Page: 9 of 72

5.11 Equipment List

Conducted Emission						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Duedate (yyyy-mm-dd)
1	Shielding Room	ZhongYu Electron	GB-88	SEM001-06	2017-05-10	2018-05-10
2	LISN	Rohde & Schwarz	ENV216	SEM007-01	2017-10-09	2018-10-09
3	LISN	ETS-LINDGREN	3816/2	SEM007-02	2017-04-14	2018-04-14
4	8 Line ISN	Fischer Custom Communications Inc.	FCC-TLISN-T8-02	EMC0120	2017-09-28	2018-09-28
5	4 Line ISN	Fischer Custom Communications Inc.	FCC-TLISN-T4-02	EMC0121	2017-09-28	2018-09-28
6	2 Line ISN	Fischer Custom Communications Inc.	FCC-TLISN-T2-02	EMC0122	2017-09-28	2018-09-28
7	EMI Test Receiver	Rohde & Schwarz	ESCI	SEM004-02	2017-04-14	2018-04-14
8	DC Power Supply	Zhao Xin	RXN-305D	SEM011-02	2017-10-09	2018-10-09

RF connected test						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Duedate (yyyy-mm-dd)
1	DC Power Supply	ZhaoXin	RXN-305D	SEM011-02	2017-10-09	2018-10-09
2	Signal Analyzer	Rohde & Schwarz	FSV	W005-02	2017-03-06	2018-03-06
3	Signal Generator	Rohde & Schwarz	SML03	SEM006-02	2017-04-14	2018-04-14
4	Power Meter	Rohde & Schwarz	NRVS	SEM014-02	2017-10-09	2018-10-09
5	Power Sensor	Agilent Technologies	U2021XA	SEM009-01	2017-10-09	2018-10-09



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

Report No.: SZEM171001110305

Page: 10 of 72

RE in Chamber						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
1	3m Semi-Anechoic Chamber	ETS-LINDGREN	N/A	SEM001-01	2017-05-10	2018-05-10
2	EMI Test Receiver	Agilent Technologies	N9038A	SEM004-05	2017-10-09	2018-10-09
3	BiConiLog Antenna (26-3000MHz)	ETS-LINDGREN	3142C	SEM003-01	2017-11-01	2020-11-01
4	Double-ridged horn (1-18GHz)	ETS-LINDGREN	3117	SEM003-11	2015-10-17	2018-10-17
5	Horn Antenna (18-26GHz)	ETS-LINDGREN	3160	SEM003-12	2017-11-24	2020-11-24
6	Pre-amplifier (0.1-1300MHz)	Agilent Technologies	8447D	SEM005-01	2017-04-14	2018-04-14
7	Band filter	Amindeon	Asi 3314	SEM023-01	N/A	N/A
8	DC Power Supply	Zhao Xin	RXN-305D	SEM011-02	2017-10-09	2018-10-09
9	Loop Antenna	Beijing Daze	ZN30401	SEM003-09	2015-05-13	2018-05-13

RE in Chamber						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (yyyy-mm-dd)	Cal. Due date (yyyy-mm-dd)
1	10m Semi-Anechoic Chamber	SAEMC	FSAC1018	SEM001-03	2017-05-10	2018-05-10
2	EMI Test Receiver (9k-7GHz)	Rohde & Schwarz	ESR	SEM004-03	2017-04-14	2018-04-14
3	Trilog-Broadband Antenna(30M-1GHz)	Schwarzbeck	VULB9168	SEM003-18	2016-06-29	2019-06-29
4	Pre-amplifier	Sonoma Instrument Co	310N	SEM005-03	2017-07-06	2018-07-06
5	Loop Antenna	ETS-Lindgren	6502	SEM003-08	2015-08-14	2018-08-14



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

Report No.: SZEM171001110305

Page: 11 of 72

RE in Chamber						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
1	3m Semi-Anechoic Chamber	AUDIX	N/A	SEM001-02	2017-05-10	2018-05-10
2	EXA Spectrum Analyzer	Agilent Technologies Inc	N9010A	SEM004-09	2017-07-19	2018-07-19
3	BiConiLog Antenna (26-3000MHz)	ETS-Lindgren	3142C	SEM003-02	2017-11-15	2020-11-15
4	Amplifier (0.1-1300MHz)	HP	8447D	SEM005-02	2017-10-09	2018-10-09
5	Horn Antenna (1-18GHz)	Rohde & Schwarz	HF907	SEM003-07	2015-06-14	2018-06-14
6	Horn Antenna (18-26GHz)	ETS-Lindgren	3160	SEM003-12	2017-11-24	2020-11-24
7	HornAntenna (26GHz-40GHz)	A.H.Systems, inc.	SAS-573	SEM003-13	2015-02-12	2018-02-12
8	Low Noise Amplifier	Black Diamond Series	BDLNA-0118-352810	SEM005-05	2017-10-09	2018-10-09
9	Band filter	Amindeon	Asi 3314	SEM023-01	N/A	N/A



6 Test results and Measurement Data

6.1 Antenna Requirement

Standard requirement:	47 CFR Part 15C Section 15.203 /247(c)
15.203 requirement:	An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.
15.247(b) (4) requirement:	The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.
The antenna is integrated on the main PCB and no consideration of replacement. The best case gain of the antenna is -1.0dBi.	

6.2 Conducted Emissions

Test Requirement:	47 CFR Part 15C Section 15.207		
Test Method:	ANSI C63.10: 2013		
Test Frequency Range:	150kHz to 30MHz		
Limit:	Frequency range (MHz)		Limit (dBuV)
	Quasi-peak		Average
	0.15-0.5	66 to 56*	56 to 46*
	0.5-5	56	46
Test Procedure:	5-30	60	50
	* Decreases with the logarithm of the frequency.		
	<ol style="list-style-type: none">1) The mains terminal disturbance voltage test was conducted in a shielded room.2) The EUT was connected to AC power source through a LISN 1 (Line Impedance Stabilization Network) which provides a $50\Omega/50\mu\text{H} + 5\Omega$ linear impedance. The power cables of all other units of the EUT were connected to a second LISN 2, which was bonded to the ground reference plane in the same way as the LISN 1 for the unit being measured. A multiple socket outlet strip was used to connect multiple power cables to a single LISN provided the rating of the LISN was not exceeded.3) The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane,4) The test was performed with a vertical ground reference plane. The rear of the EUT shall be 0.4 m from the vertical ground reference plane. The vertical ground reference plane was bonded to the horizontal ground reference plane. The LISN 1 was placed 0.8 m from the boundary of the unit under test and bonded to a ground reference plane for LISNs mounted on top of the ground reference plane. This distance was between the closest points of the LISN 1 and the EUT. All other units of the EUT and associated equipment was at least 0.8 m from the LISN 2.5) In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.10: 2013 on conducted measurement.		

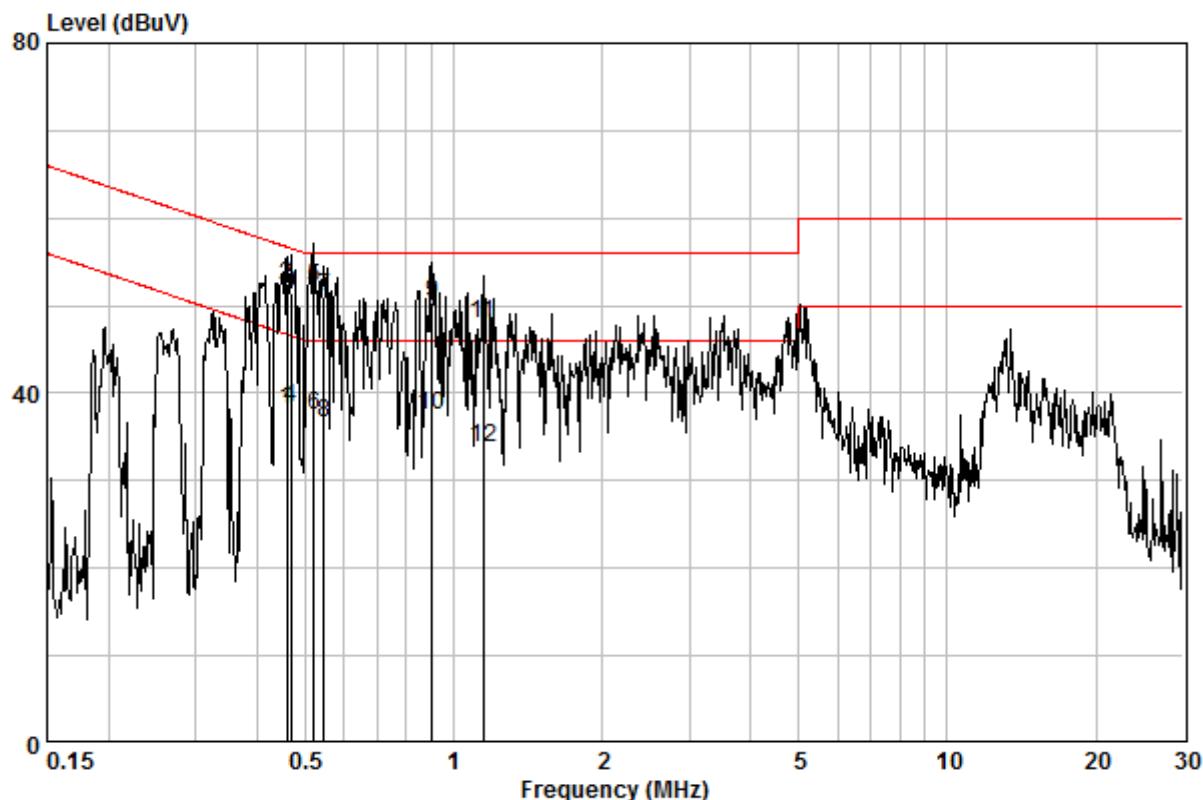
Test Setup:	
Exploratory Test Mode:	Non-hopping transmitting mode with all kind of modulation and all kind of data type at the lowest, middle, high channel. Charge + Transmitting mode.
Final Test Mode:	Through Pre-scan, find the DH1 of data type and GFSK modulation at the lowest channel is the worst case. Charge + Transmitting mode Only the worst case is recorded in the report.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass

Measurement Data

An initial pre-scan was performed on the live and neutral lines with peak detector.

Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission were detected.

Live line:



Site : Shielding Room

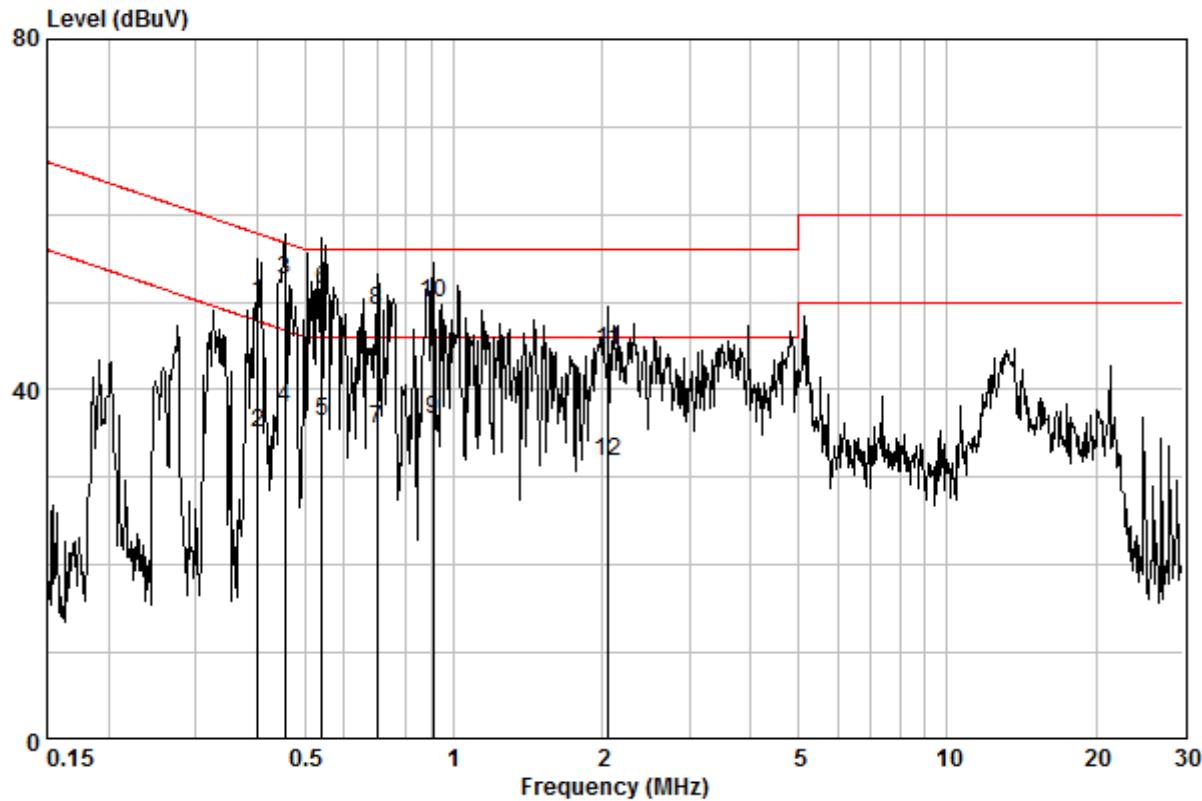
Condition : CE LINE

Job No. : 03519RG

Test Mode : c

	Freq	Cable	LISN	Read	Limit	Over	Remark
		Loss	Factor	Level			
	MHz	dB	dB	dBuV	dBuV	dBuV	dB
1	0.45878	0.02	9.64	28.59	38.25	46.71	-8.46 AVERAGE
2	0.45878	0.02	9.64	42.70	52.36	56.71	-4.35 QP
3	0.46861	0.02	9.64	41.83	51.49	56.54	-5.05 QP
4	0.46861	0.02	9.64	28.63	38.29	46.54	-8.25 AVERAGE
5	0.52099	0.02	9.64	42.52	52.18	56.00	-3.82 QP
6	0.52099	0.02	9.64	27.74	37.40	46.00	-8.60 AVERAGE
7	0.54644	0.02	9.64	41.35	51.02	56.00	-4.98 QP
8	0.54644	0.02	9.64	26.87	36.54	46.00	-9.46 AVERAGE
9	0.90394	0.03	9.65	40.69	50.37	56.00	-5.63 QP
10	0.90394	0.03	9.65	27.80	37.48	46.00	-8.52 AVERAGE
11	1.147	0.03	9.66	38.35	48.03	56.00	-7.97 QP
12	1.147	0.03	9.66	24.16	33.85	46.00	-12.15 AVERAGE

Neutral line:



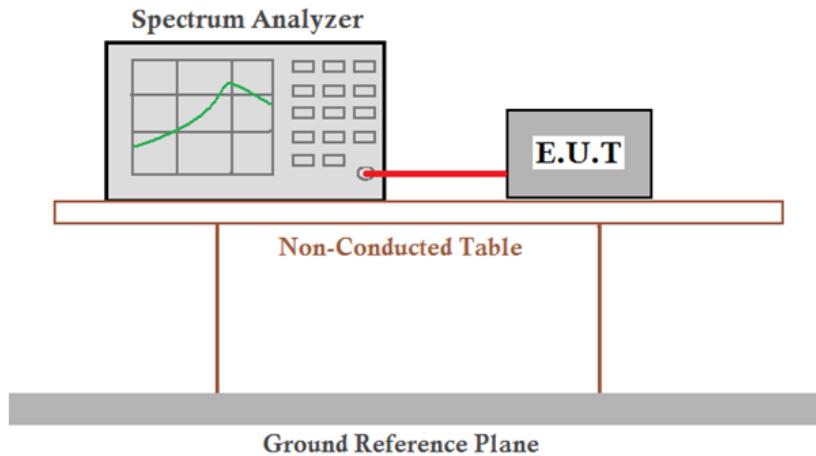
Site : Shielding Room
 Condition : CE NEUTRAL
 Job No. : 03519RG
 Test Mode : c

	Freq	Cable	LISN	Read	Limit	Over	Remark
		Loss	Factor	Level	Level	Line	
	MHz	dB	dB	dBuV	dBuV	dBuV	dB
1	0.40187	0.02	9.63	40.16	49.81	57.81	-8.01 QP
2	0.40187	0.02	9.63	25.41	35.06	47.81	-12.75 AVERAGE
3	0.45395	0.02	9.63	42.86	52.51	56.80	-4.30 QP
4	0.45395	0.02	9.63	28.22	37.87	46.80	-8.93 AVERAGE
5	0.54068	0.02	9.63	26.75	36.40	46.00	-9.60 AVERAGE
6	0.54068	0.02	9.63	41.76	51.41	56.00	-4.59 QP
7	0.70096	0.02	9.64	25.85	35.52	46.00	-10.48 AVERAGE
8	0.70096	0.02	9.64	39.33	49.00	56.00	-7.00 QP
9	0.90874	0.03	9.64	26.90	36.57	46.00	-9.43 AVERAGE
10	0.90874	0.03	9.64	40.23	49.90	56.00	-6.10 QP
11	2.055	0.03	9.66	34.80	44.49	56.00	-11.51 QP
12	2.055	0.03	9.66	22.12	31.81	46.00	-14.19 AVERAGE

Notes:

1. The following Quasi-Peak and Average measurements were performed on the EUT:
2. Final Test Level = Receiver Reading + LISN Factor + Cable Loss.

6.3 Conducted Peak Output Power

Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.5
Test Setup:	 <p style="text-align: center;">Spectrum Analyzer E.U.T Non-Conducted Table Ground Reference Plane</p>
	<p><i>Remark:</i> <i>Offset the High-Frequency cable loss 1dB in the spectrum analyzer.</i></p>
Limit:	20.97dBm) 125mW
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type.
Final Test Mode:	Through Pre-scan, find the DH1 of data type is the worst case of GFSK modulation type, 2-DH1 of data type is the worst case of $\pi/4$ DQPSK modulation type, 3-DH1 of data type is the worst case of 8DPSK modulation type.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

Report No.: SZEM171001110305

Page: 18 of 72

Measurement Data

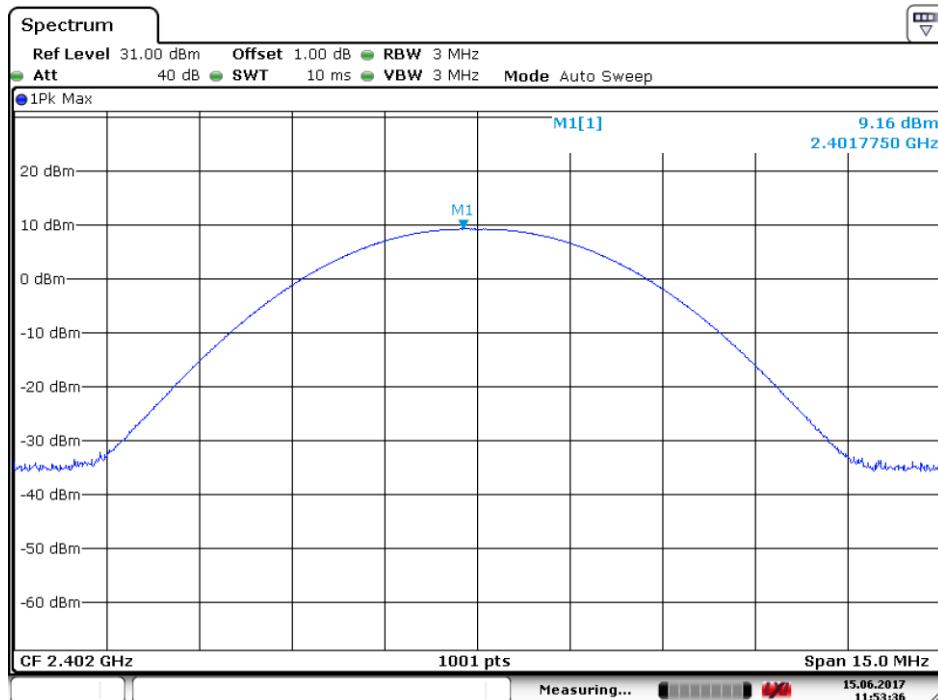
GFSK mode			
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	9.16	20.97	Pass
Middle	9.11	20.97	Pass
Highest	8.93	20.97	Pass

π/4DQPSK mode			
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	9.89	20.97	Pass
Middle	9.84	20.97	Pass
Highest	9.67	20.97	Pass

8DPSK mode			
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	10.09	20.97	Pass
Middle	10.03	20.97	Pass
Highest	9.87	20.97	Pass

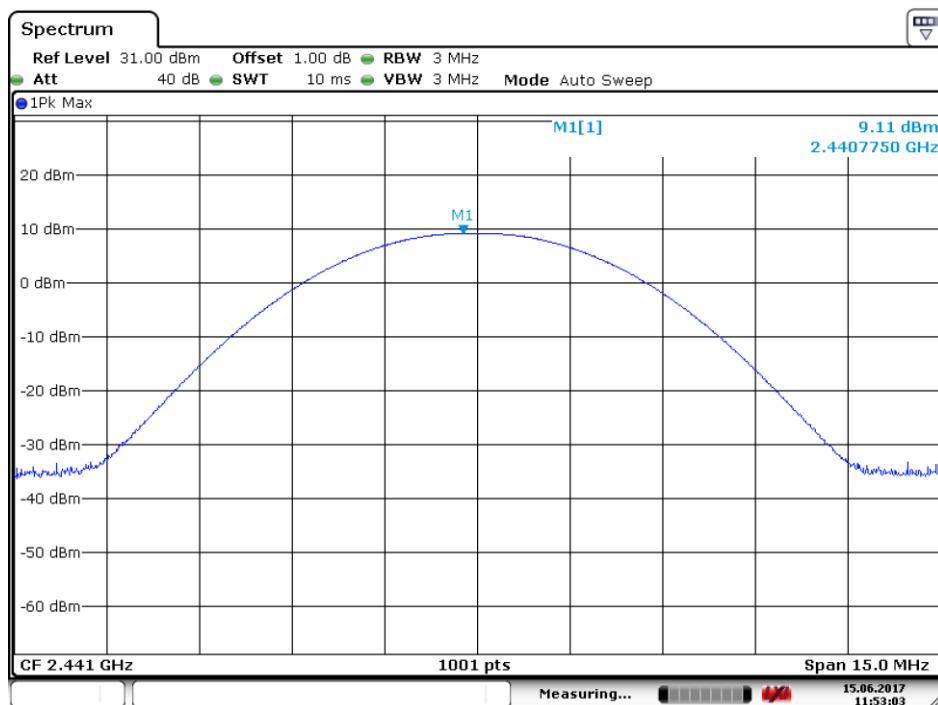
Test plot as follows:

Test mode:	GFSK	Test channel:	Lowest
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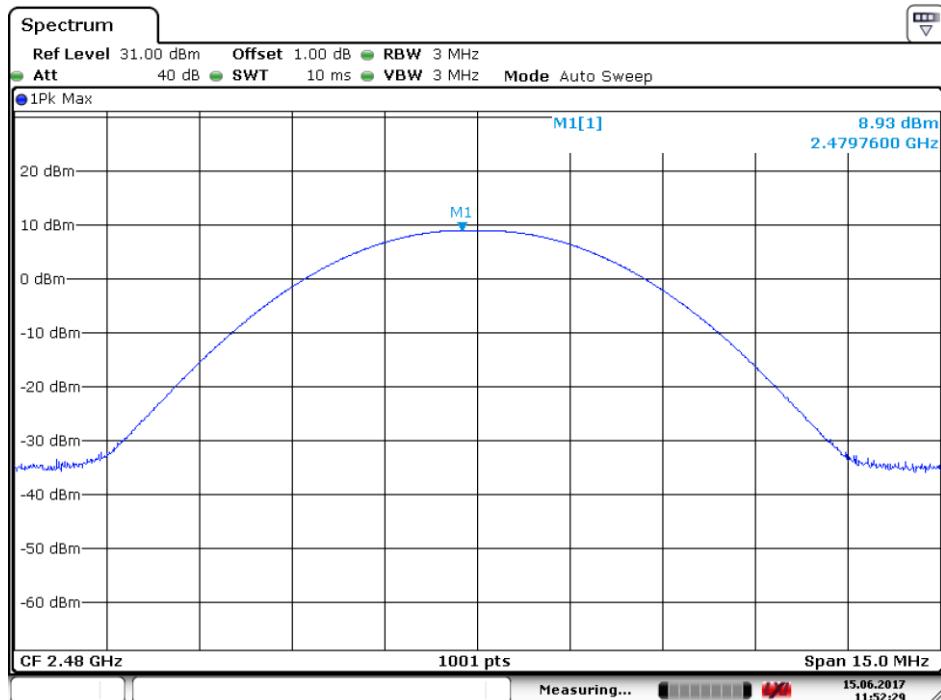
Date: 15.JUN.2017 11:53:36

Test mode:	GFSK	Test channel:	Middle
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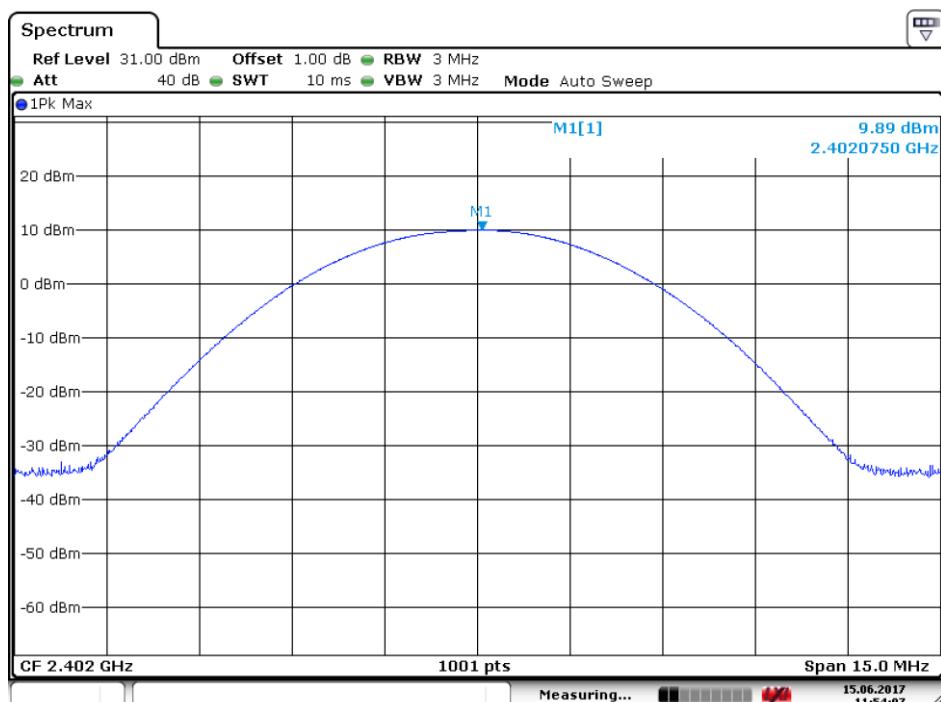
Date: 15.JUN.2017 11:53:04

Test mode:	GFSK	Test channel:	Highest
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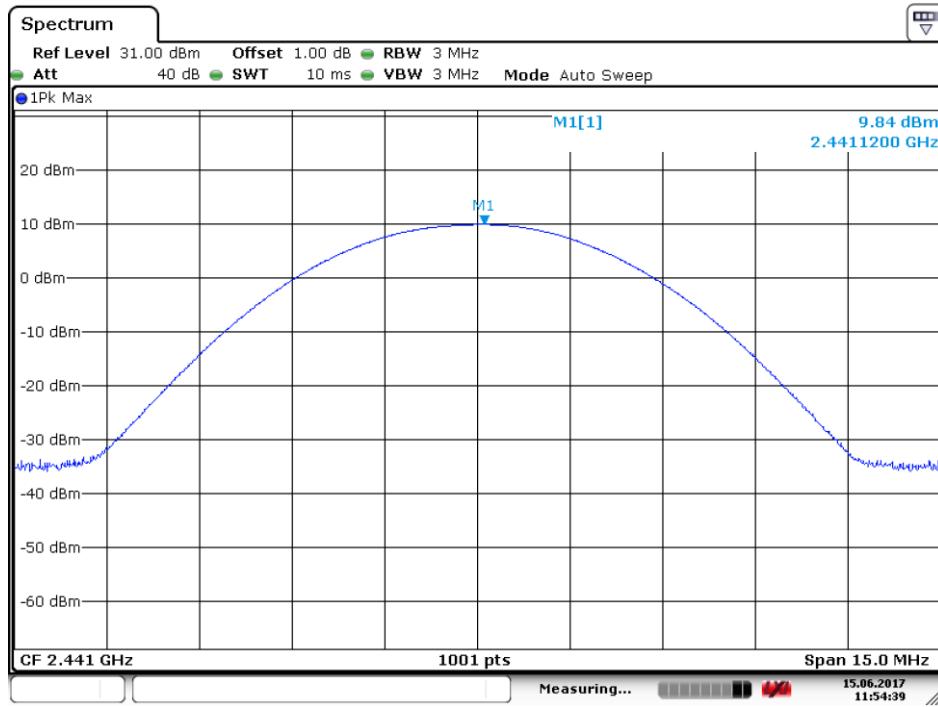
Date: 15.JUN.2017 11:52:29

Test mode:	π/4DQPSK	Test channel:	Lowest
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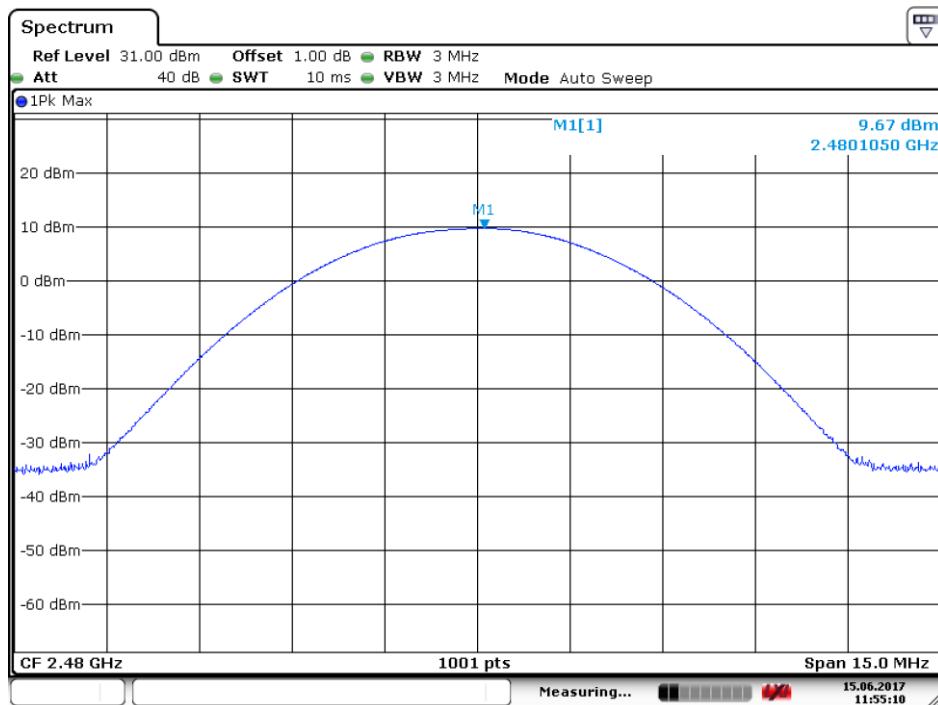
Date: 15.JUN.2017 11:54:07

Test mode:	π/4DQPSK	Test channel:	Middle
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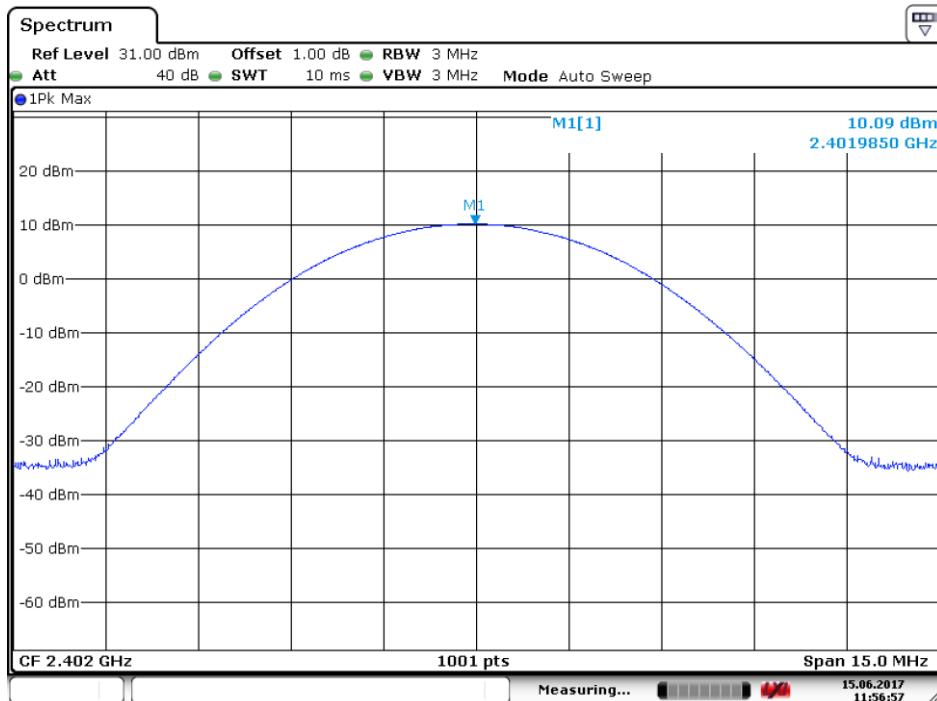
Date: 15.JUN.2017 11:54:39

Test mode:	π/4DQPSK	Test channel:	Highest
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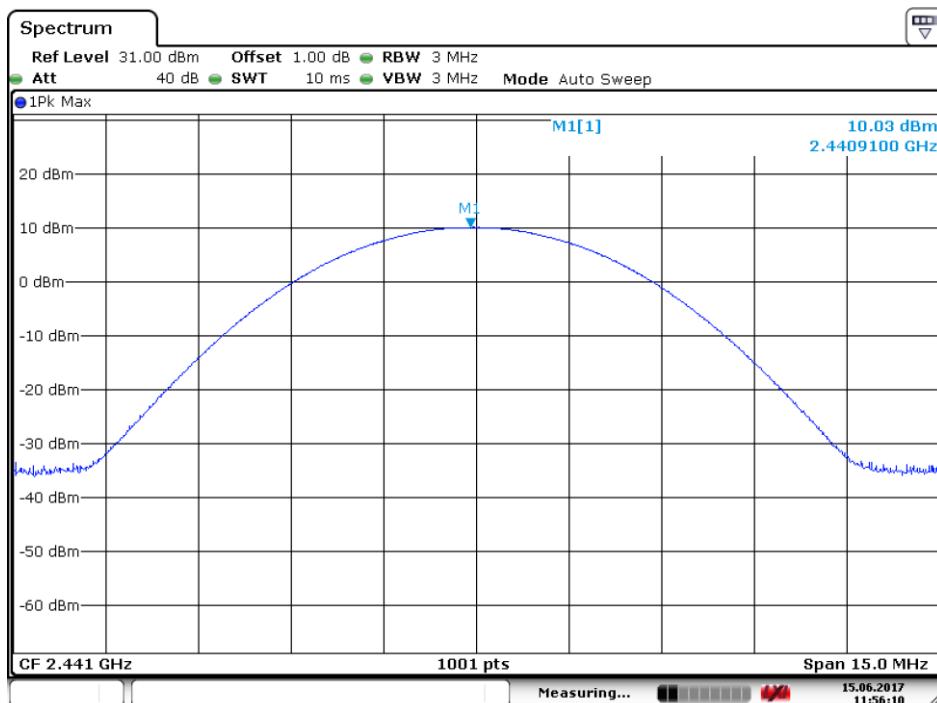
Date: 15.JUN.2017 11:55:10

Test mode:	8DPSK	Test channel:	Lowest
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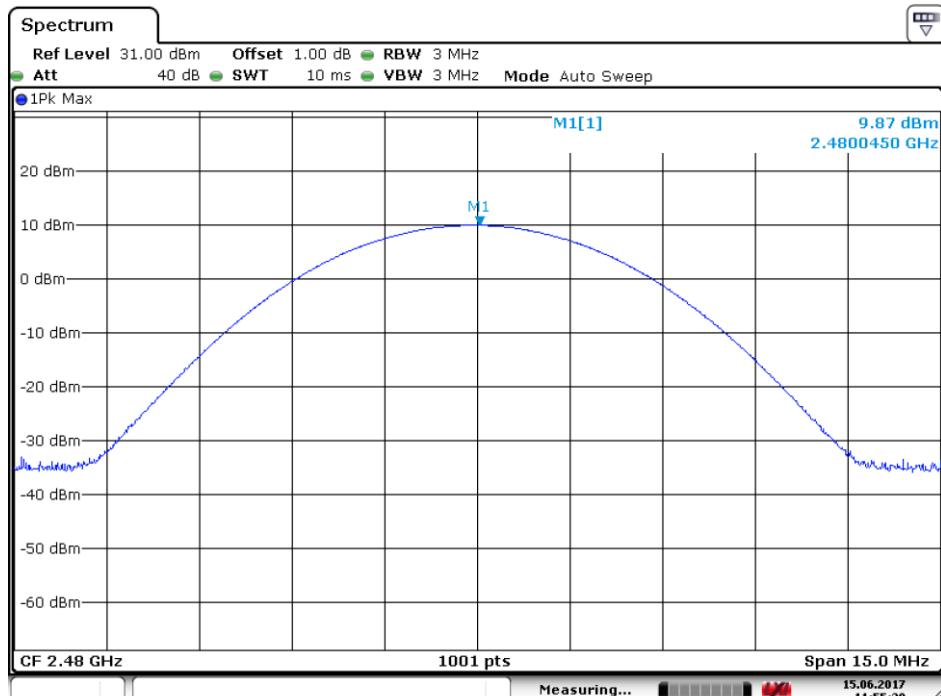
Date: 15.JUN.2017 11:56:58

Test mode:	8DPSK	Test channel:	Middle
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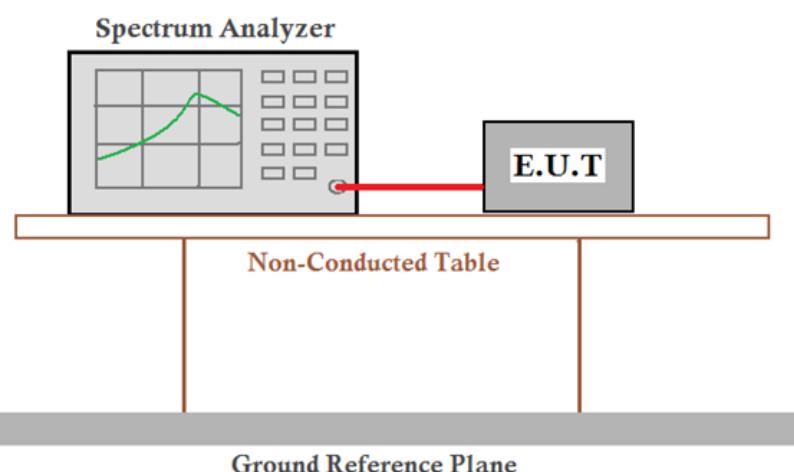
Date: 15.JUN.2017 11:56:10

Test mode:	8DPSK	Test channel:	Highest
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Date: 15.JUN.2017 11:55:39

6.4 20dB Occupy Bandwidth

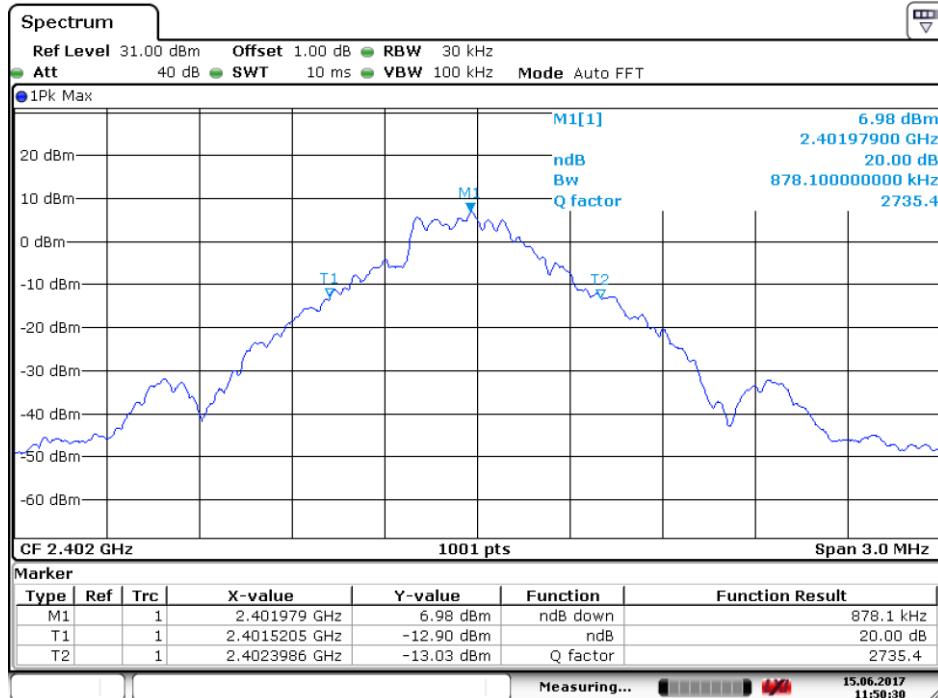
Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.7
Test Setup:	
Limit:	NA
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type.
Final Test Mode:	Through Pre-scan, find the DH1 of data type is the worst case of GFSK modulation type, 2-DH1 of data type is the worst case of $\pi/4$ DQPSK modulation type, 3-DH1 of data type is the worst case of 8DPSK modulation type.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass

Measurement Data

Test channel	20dB Occupy Bandwidth (kHz)		
	GFSK	$\pi/4$ DQPSK	8DPSK
Lowest	878.1	1252.7	1216.8
Middle	878.1	1252.7	1219.8
Highest	881.1	1252.7	1219.8

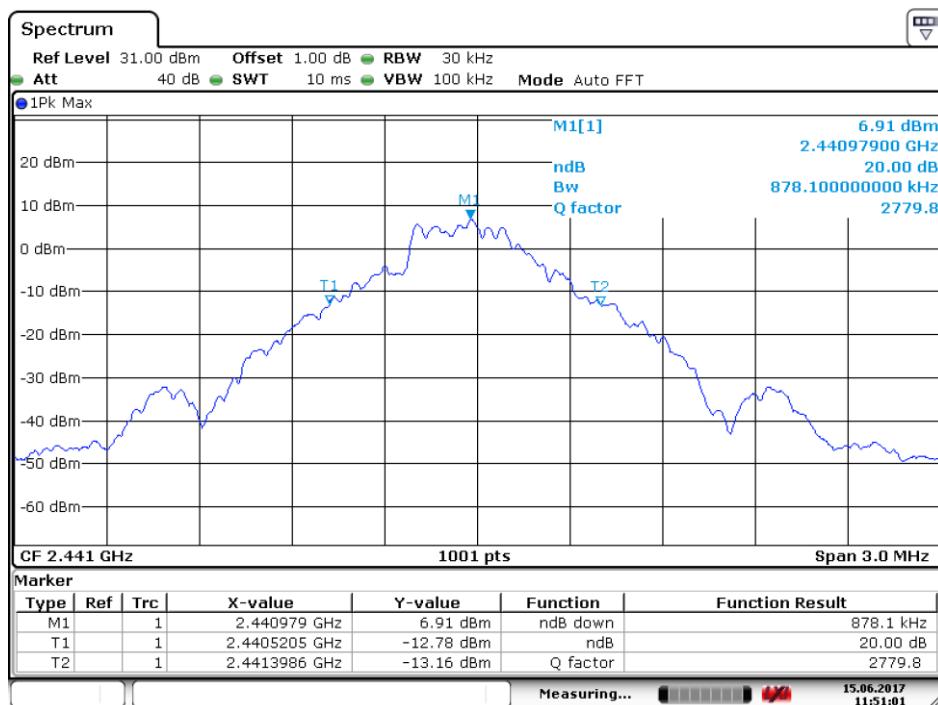
Test plot as follows:

Test mode:	GFSK	Test channel:	Lowest
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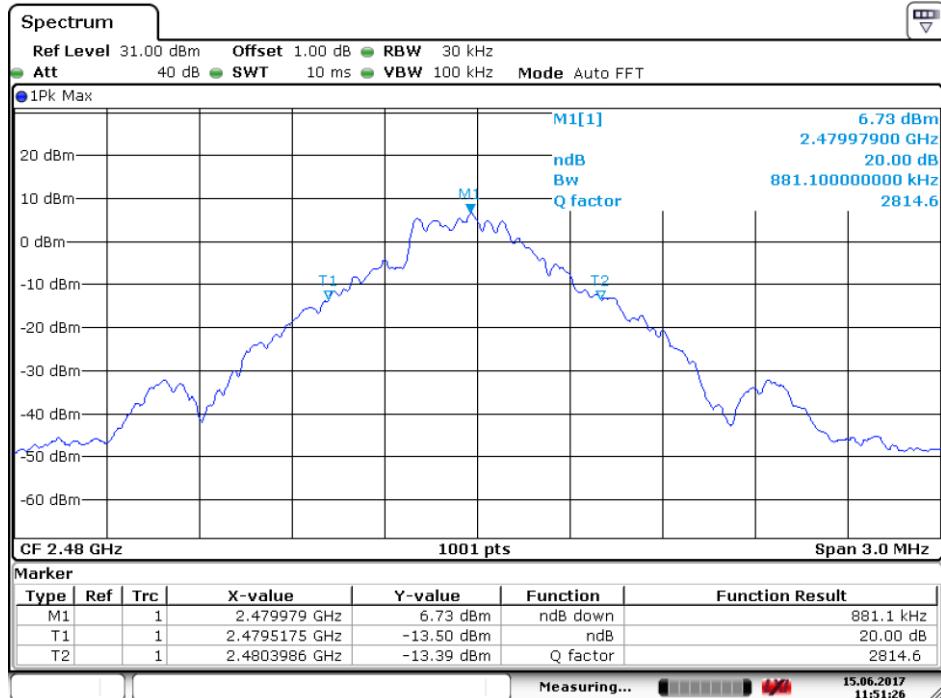
Date: 15.JUN.2017 11:50:31

Test mode:	GFSK	Test channel:	Middle
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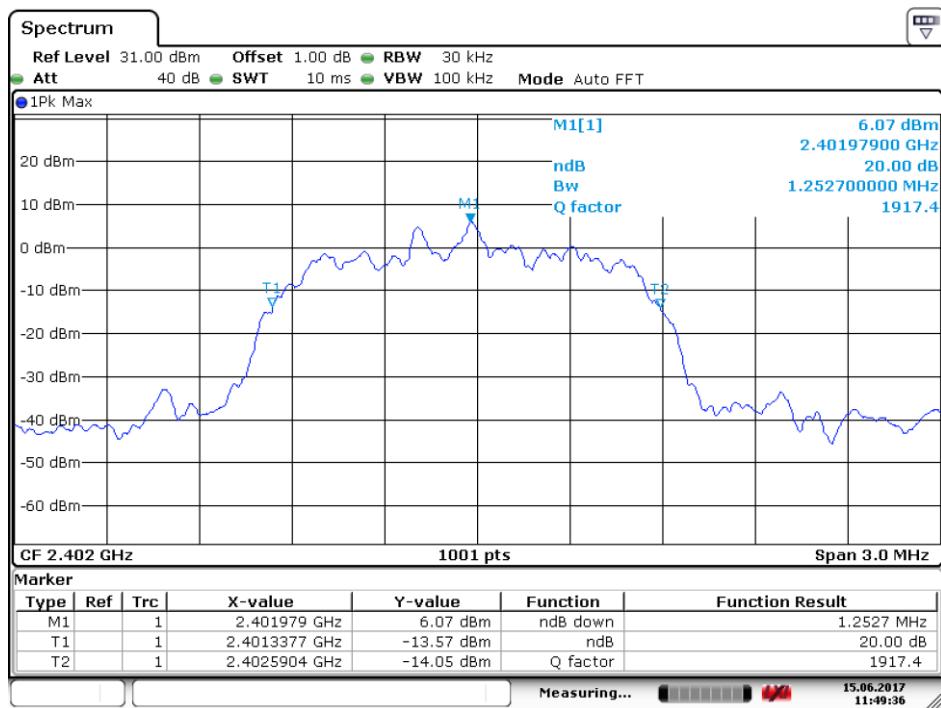
Date: 15.JUN.2017 11:51:01

Test mode:	GFSK	Test channel:	Highest
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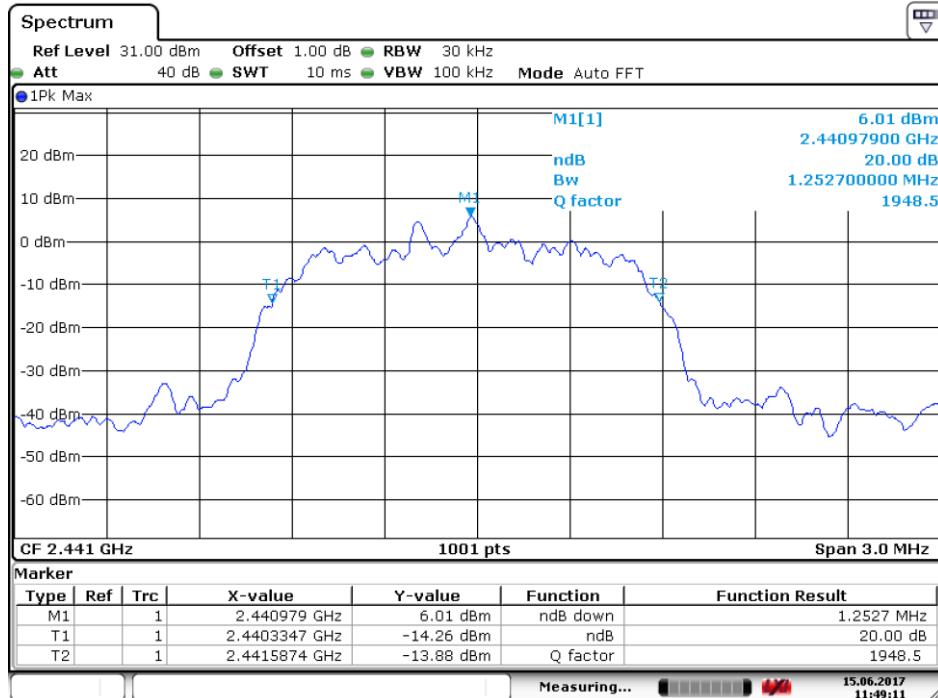
Date: 15.JUN.2017 11:51:27

Test mode:	$\pi/4$ DQPSK	Test channel:	Lowest
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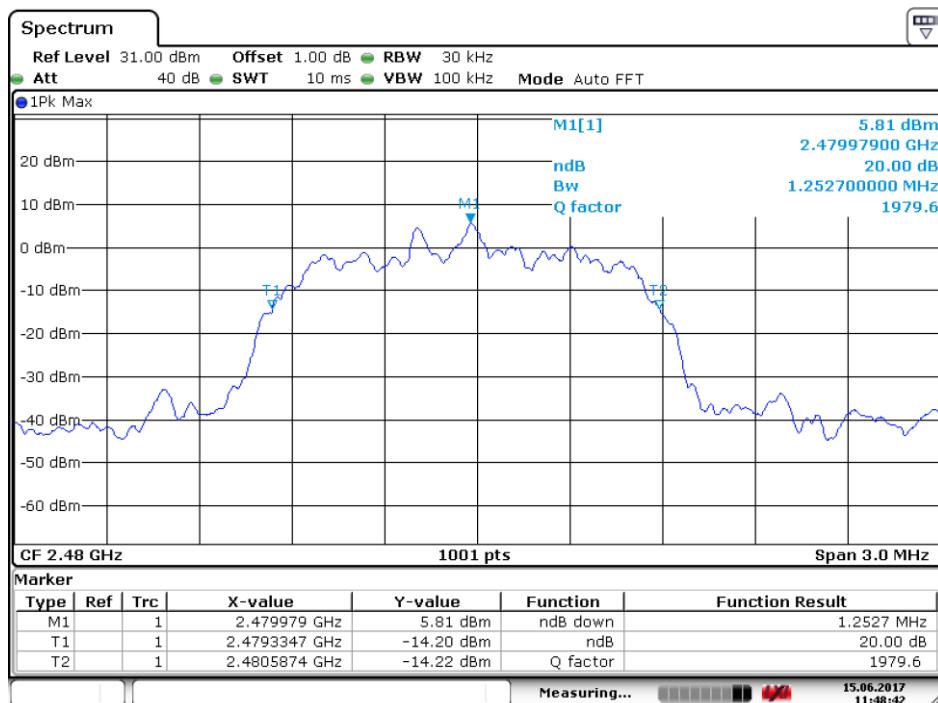
Date: 15.JUN.2017 11:49:37

Test mode:	$\pi/4$ DQPSK	Test channel:	Middle
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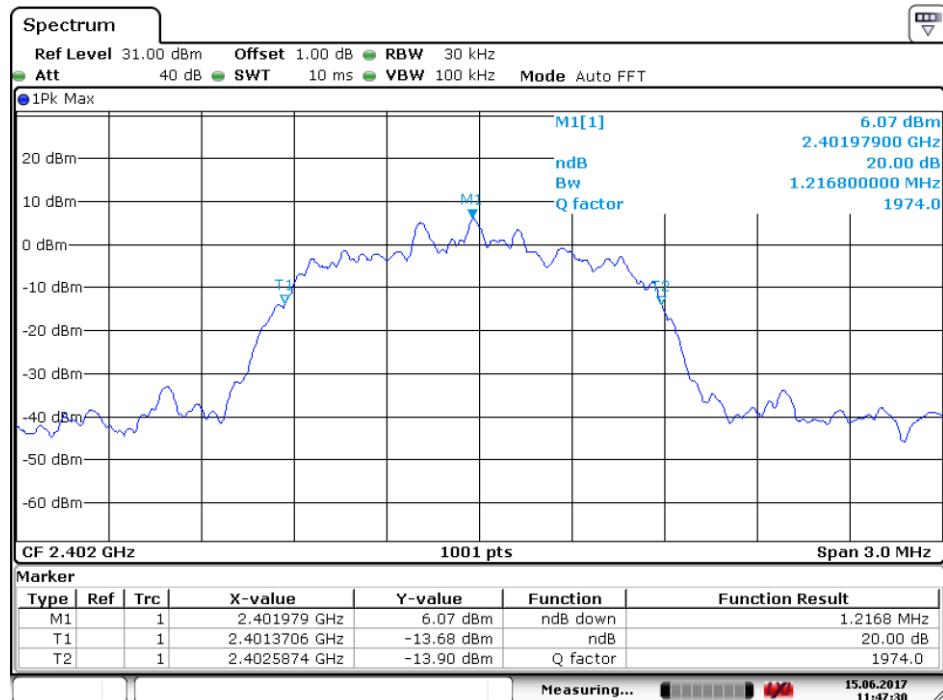
Date: 15.JUN.2017 11:49:12

Test mode:	$\pi/4$ DQPSK	Test channel:	Highest
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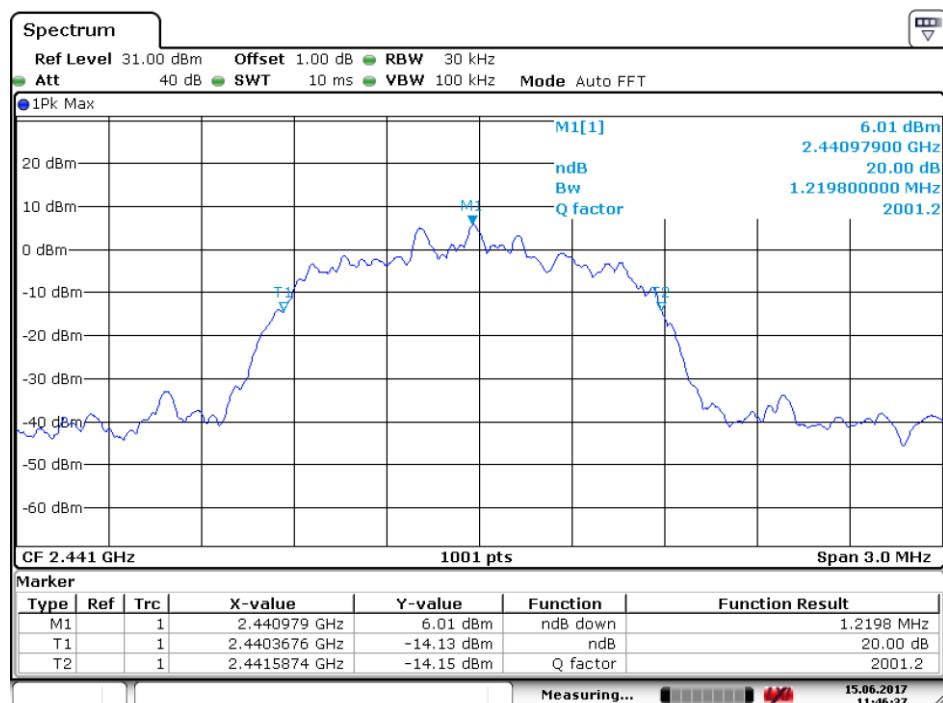
Date: 15.JUN.2017 11:48:42

Test mode:	8DPSK	Test channel:	Lowest
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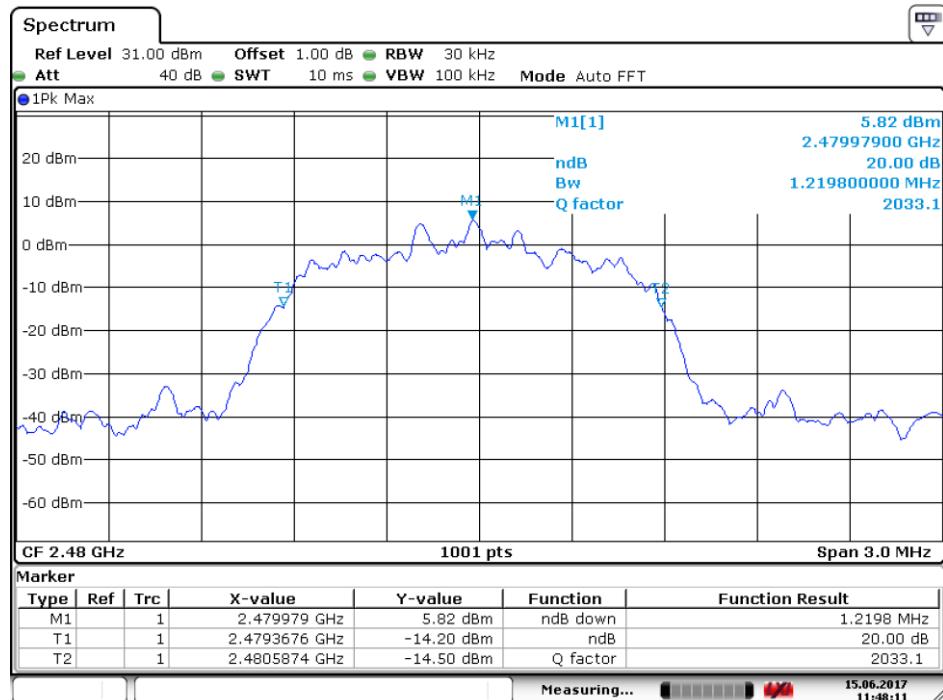
Date: 15.JUN.2017 11:47:30

Test mode:	8DPSK	Test channel:	Middle
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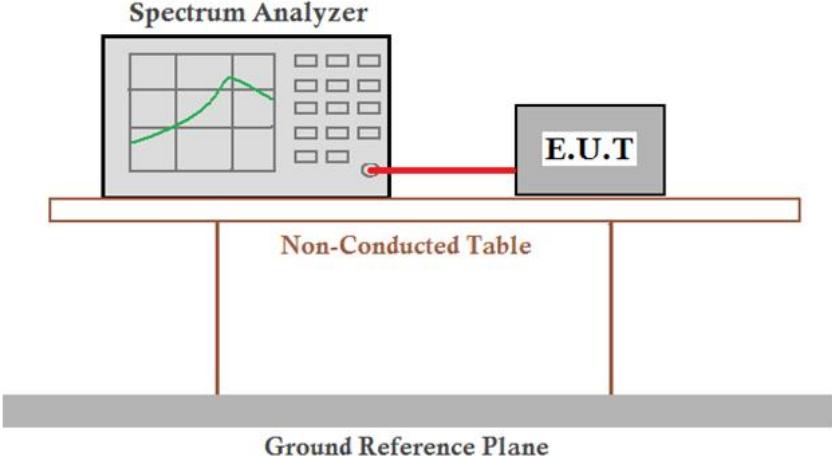
Date: 15.JUN.2017 11:46:38

Test mode:	8DPSK	Test channel:	Highest
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Date: 15.JUN.2017 11:48:11

6.5 Carrier Frequencies Separation

Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.2
Test Setup:	
Limit:	2/3 of the 20dB bandwidth Remark: the transmission power is less than 0.125W.
Exploratory Test Mode:	Hopping transmitting with all kind of modulation and all kind of data type.
Final Test Mode:	Through Pre-scan, find the DH1 of data type is the worst case of GFSK modulation type, 2-DH1 of data type is the worst case of π/4DQPSK modulation type, 3-DH1 of data type is the worst case of 8DPSK modulation type.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass



**SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch**

Report No.: SZEM171001110305

Page: 31 of 72

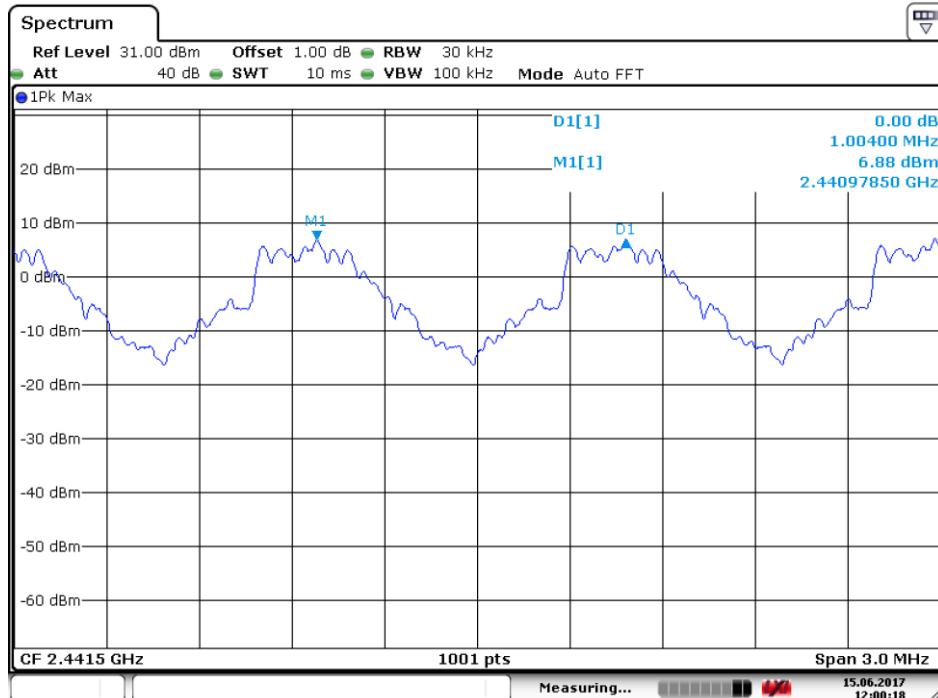
GFSK mode			
Test channel	Carrier Frequencies Separation (kHz)	Limit (kHz)	Result
Middle	1004	587.4	Pass
$\pi/4$ DQPSK mode			
Test channel	Carrier Frequencies Separation (kHz)	Limit (kHz)	Result
Middle	1001	835.1	Pass
8DPSK mode			
Test channel	Carrier Frequencies Separation (kHz)	Limit (kHz)	Result
Middle	1004	813.2	Pass

Note: According to section 6.4,

Mode	20dB bandwidth (kHz) (worse case)	Limit (kHz) (Carrier Frequencies Separation)
GFSK	881.1	587.4
$\pi/4$ DQPSK	1252.7	835.1
8DPSK	1219.8	813.2

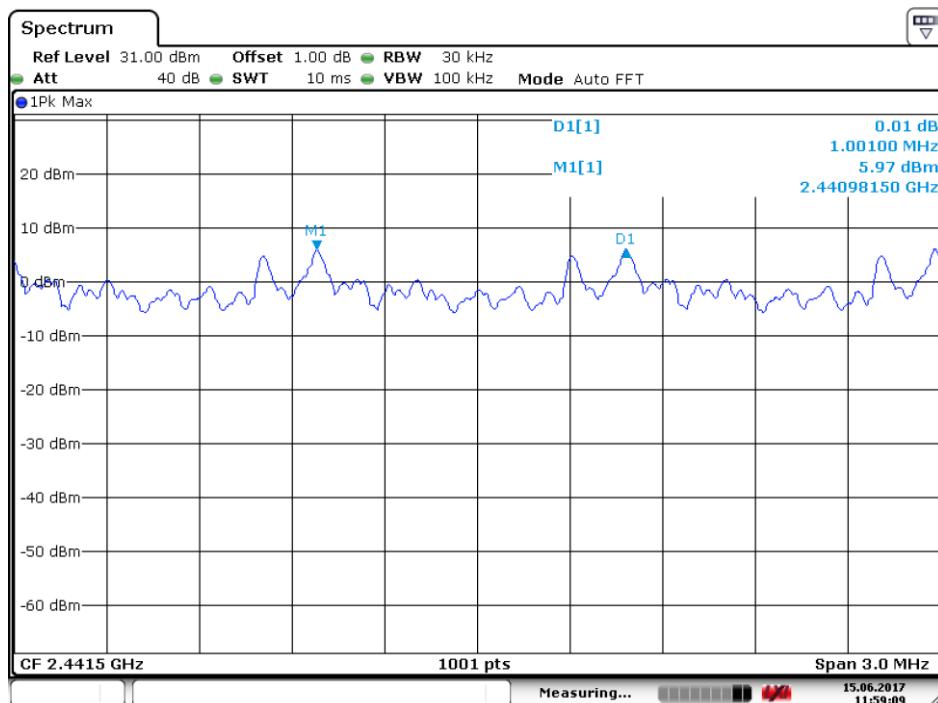
Test plot as follows:

Test mode:	GFSK	Test channel:	Middle
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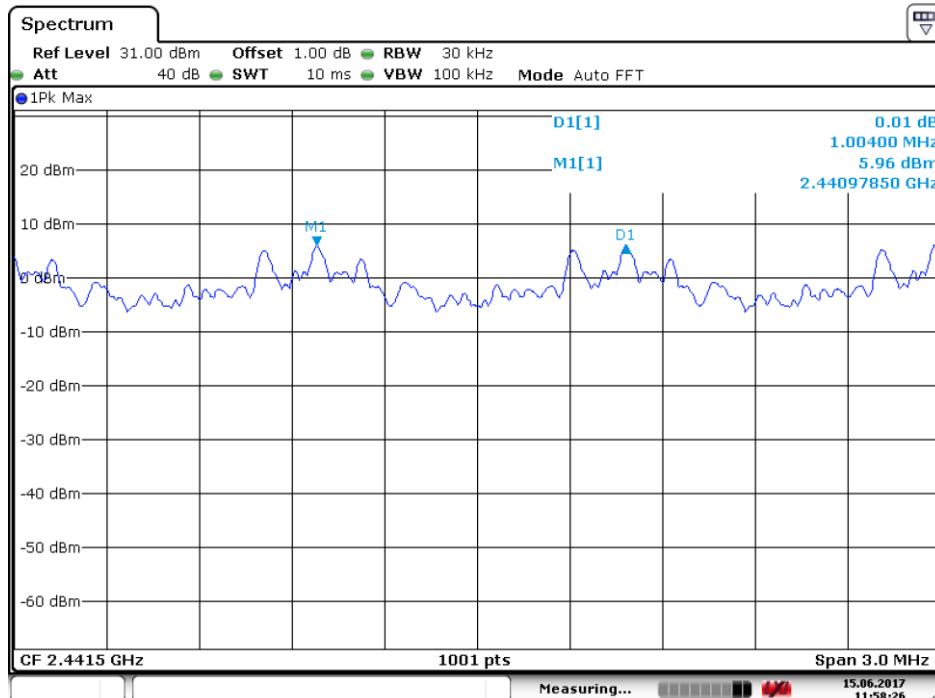
Date: 15.JUN.2017 12:00:18

Test mode:	π/4DQPSK	Test channel:	Middle
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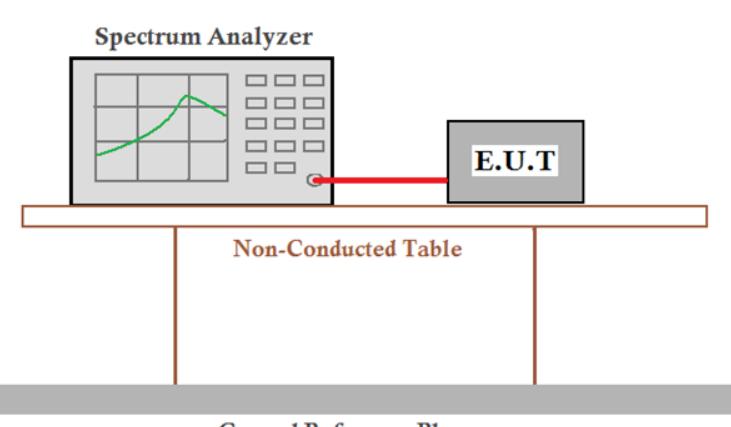
Date: 15.JUN.2017 11:59:09

Test mode:	8DPSK	Test channel:	Middle
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Date: 15.JUN.2017 11:58:26

6.6 Hopping Channel Number

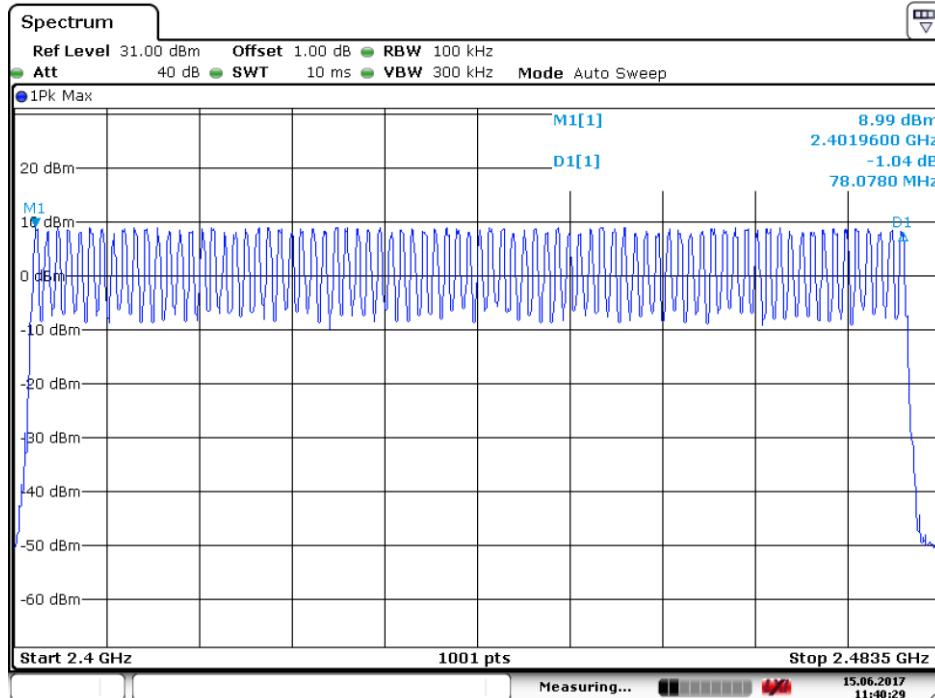
Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.3
Test Setup:	
Limit:	At least 15 channels
Test Mode:	Hopping transmitting with all kind of modulation
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass

Measurement Data

Mode	Hopping channel numbers	Limit
GFSK	79	≥15
π/4DQPSK	79	≥15
8DPSK	79	≥15

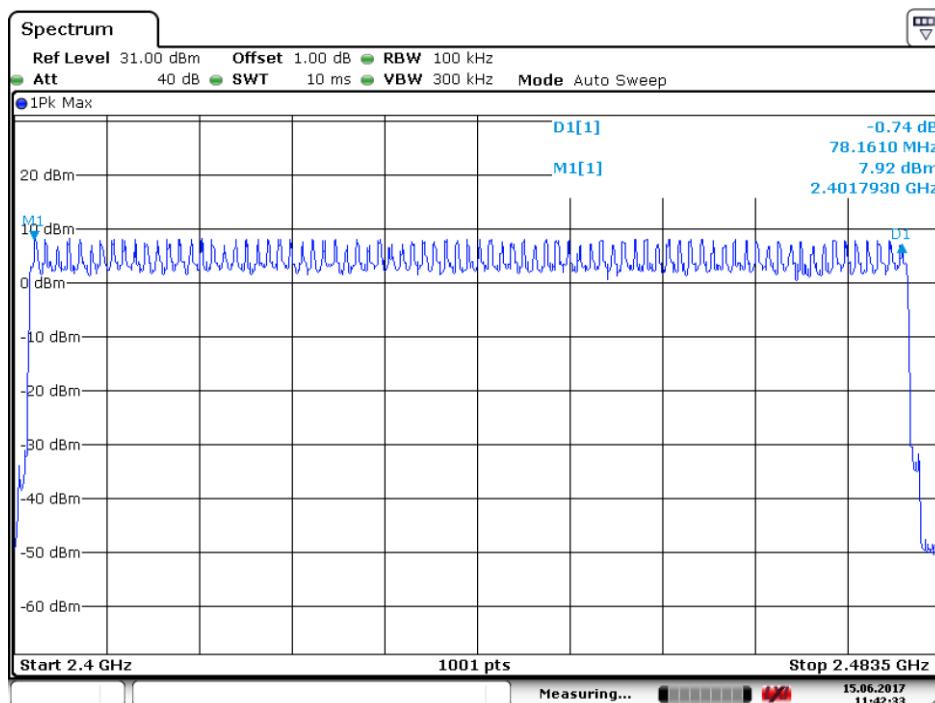
Test plot as follows

Test mode:	GFSK
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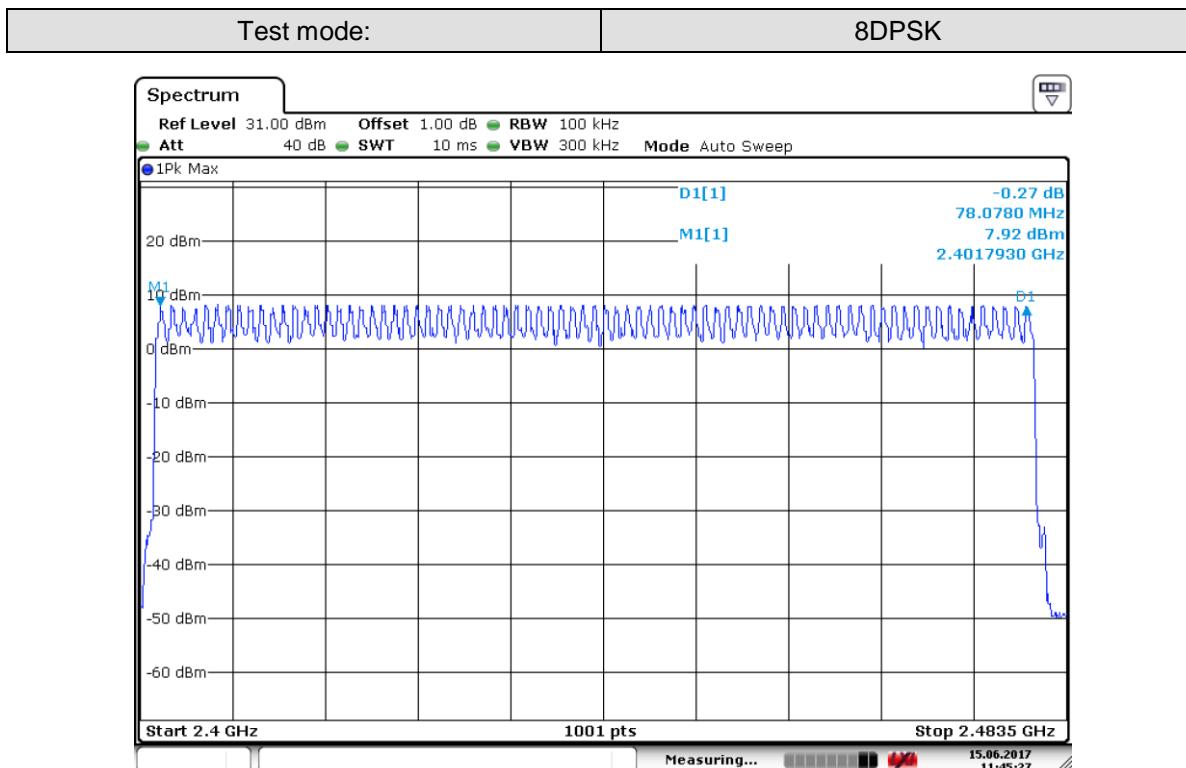


Date: 15.JUN.2017 11:40:29

Test mode:	π/4DQPSK
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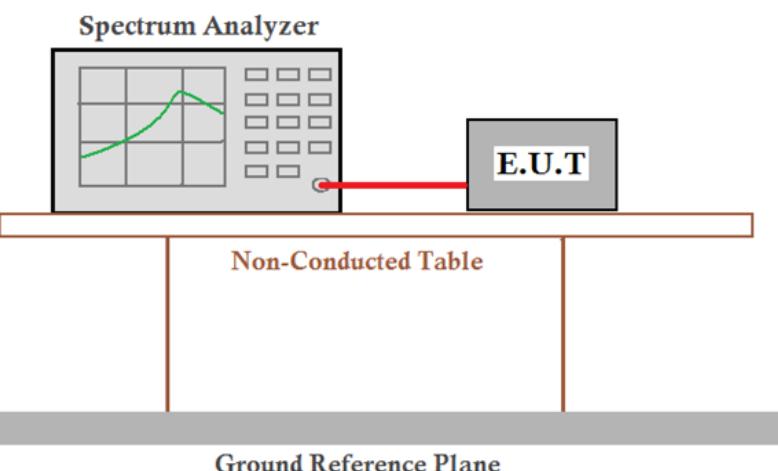


Date: 15.JUN.2017 11:42:32



Date: 15.JUN.2017 11:45:28

6.7 Dwell Time

Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.4
Test Setup:	
Instruments Used:	Refer to section 5.10 for details
Test Mode:	Hopping transmitting with all kind of modulation and all kind of data type.
Limit:	0.4 Second
Test Results:	Pass

Measurement Data

Mode	Packet	Dwell time (second)	Limit (second)
GFSK	DH1	0.124	≤0.4
	DH3	0.233	≤0.4
	DH5	0.320	≤0.4
π/4DQPSK	2-DH1	0.126	≤0.4
	2-DH3	0.183	≤0.4
	2-DH5	0.320	≤0.4
8DPSK	3-DH1	0.122	≤0.4
	3-DH3	0.233	≤0.4
	3-DH5	0.379	≤0.4



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

Report No.: SZEM171001110305

Page: 38 of 72

Remark:

The test period: $T = 0.4 \text{ Second/Channel} \times 79 \text{ Channel} = 31.6 \text{ s}$

On (ms)*total number=dwell time (ms)

The middle channel (2441MHz), as below:

DH1 time slot=0.401 (ms)*total number=124.31 (ms)

DH3 time slot=1.662(ms)* total number = 232.68 (ms)

DH5 time slot=2.907 (ms)* total number = 319.77 (ms)

2-DH1 time slot=0.407 (ms)*total number=126.17 (ms)

2-DH3 time slot=1.662 (ms)* total number = 182.82 (ms)

2-DH5 time slot=2.907 (ms)* total number = 319.77 (ms)

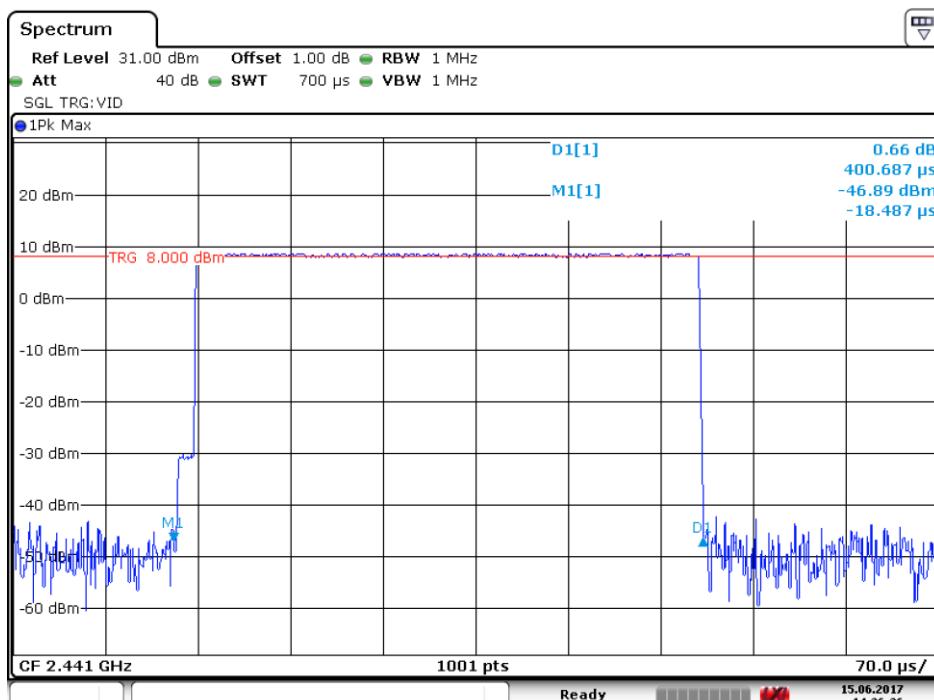
3-DH1 time slot=0.408 (ms)*total number=122.40 (ms)

3-DH3 time slot=1.662 (ms)* total number = 232.68 (ms)

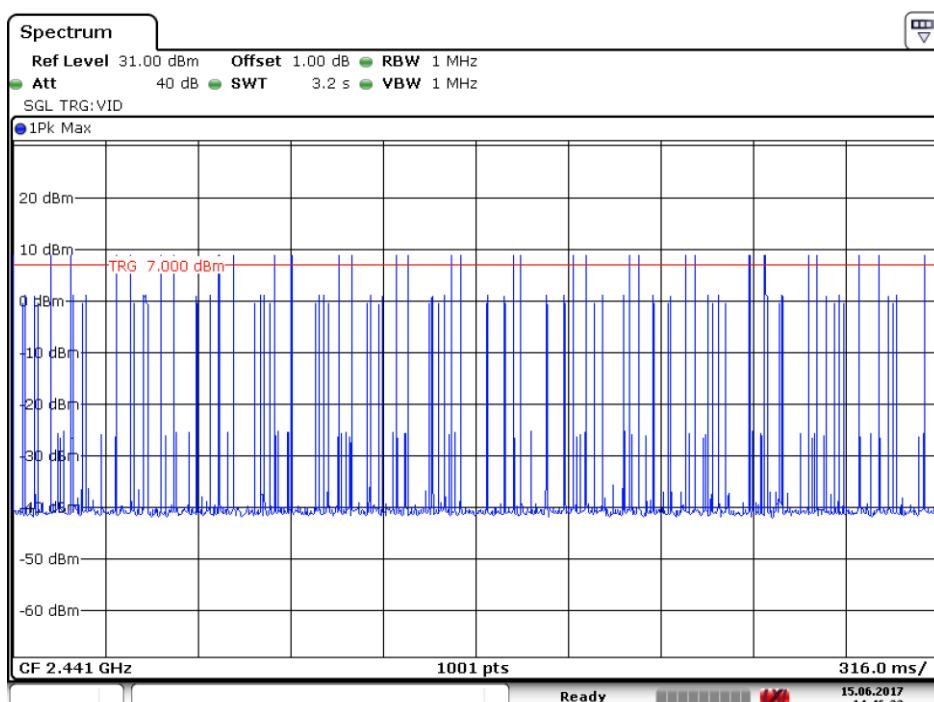
3-DH5 time slot=2.912 (ms)* total number = 378.56 (ms)

Test plot as follows:

Test Packet:	DH1
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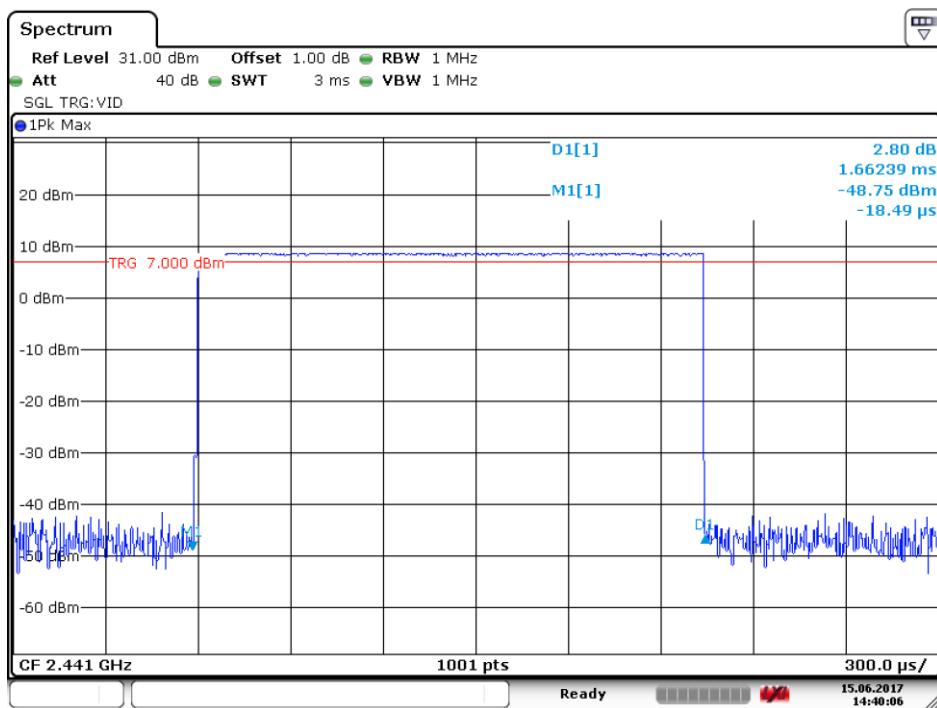


Date: 15.JUN.2017 14:36:36

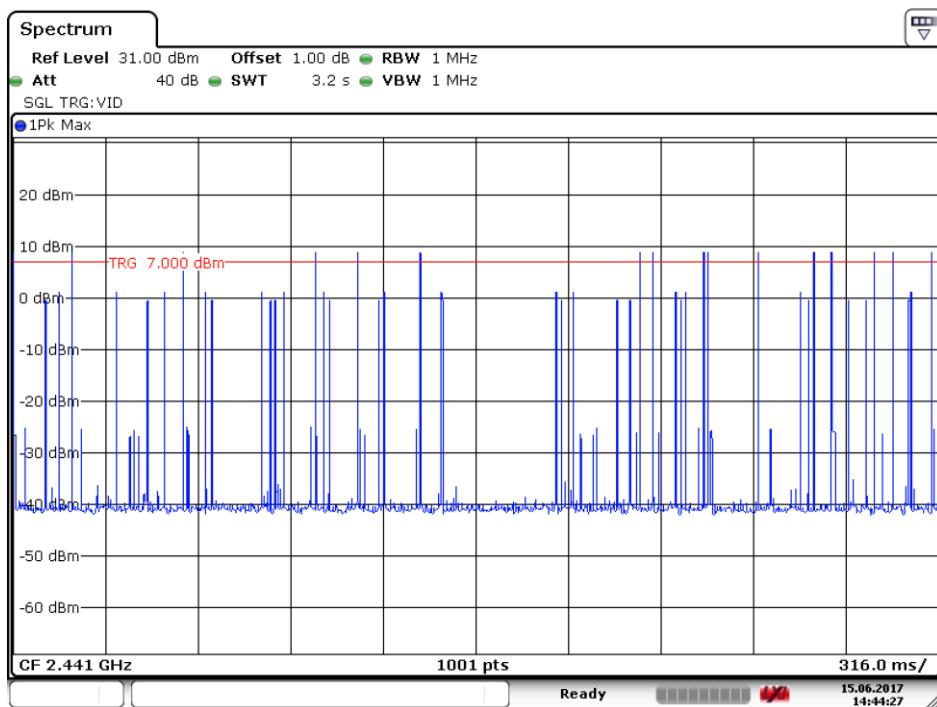


Date: 15.JUN.2017 14:46:23

Test Packet:	DH3
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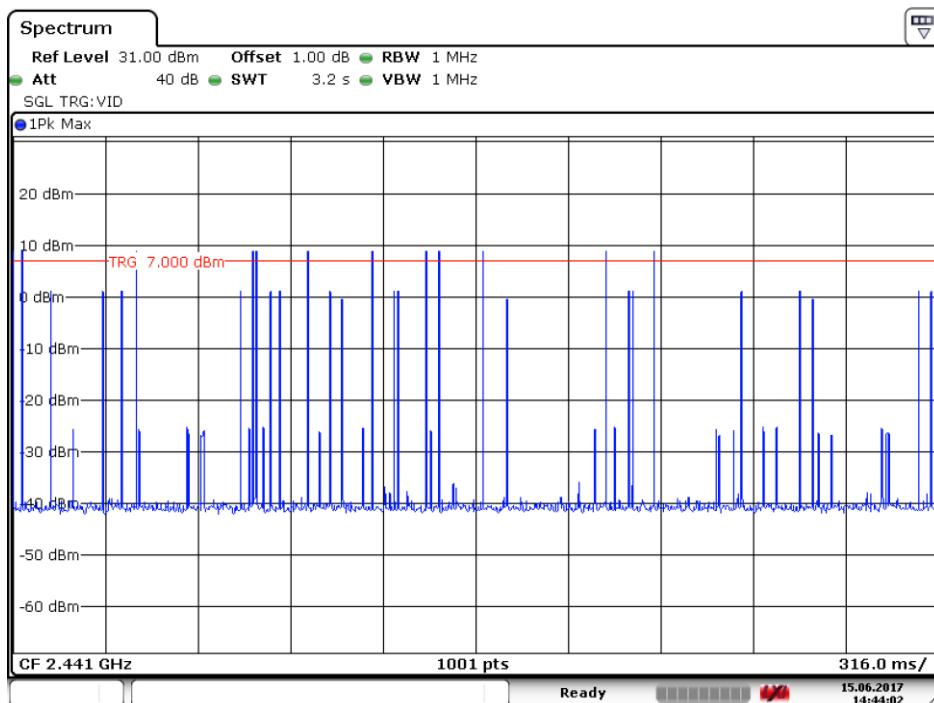


Date: 15.JUN.2017 14:40:06

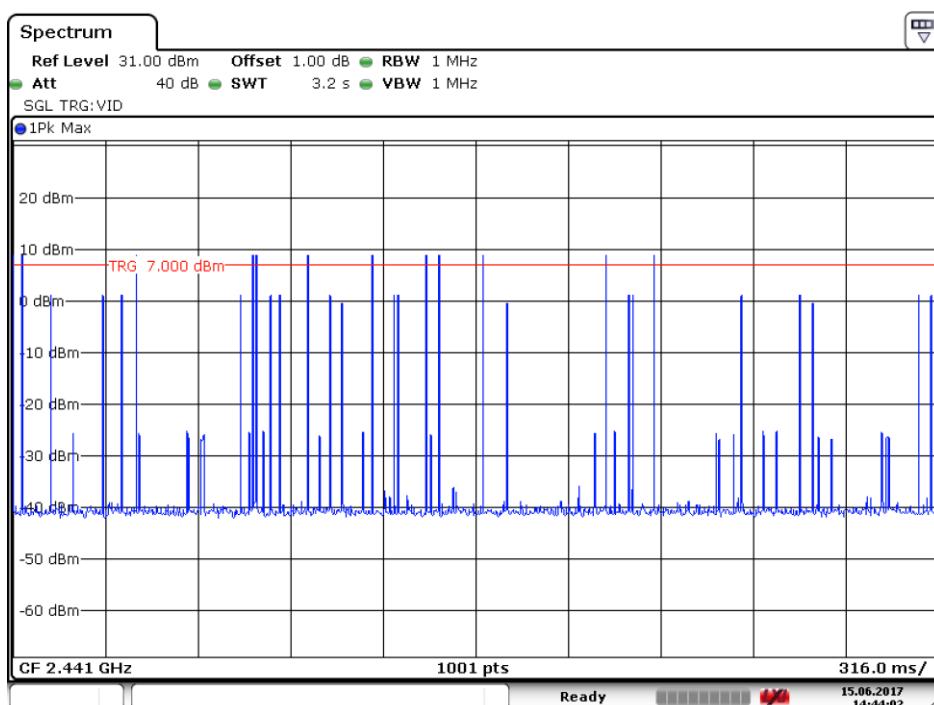


Date: 15.JUN.2017 14:44:27

Test Packet:	DH5
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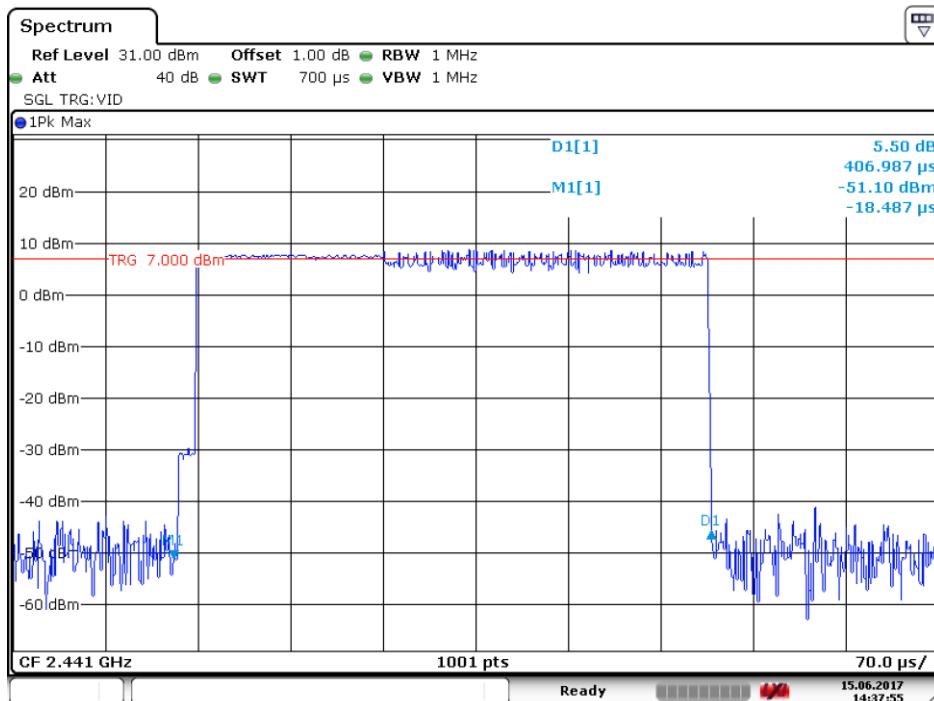


Date: 15.JUN.2017 14:44:03



Date: 15.JUN.2017 14:44:03

Test Packet:	2-DH1
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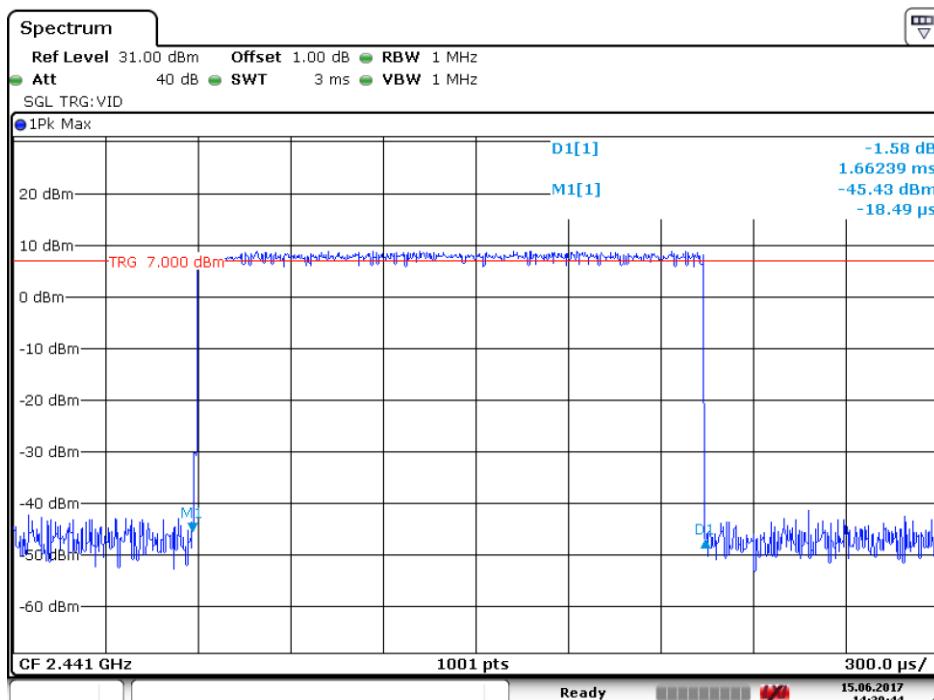


Date: 15.JUN.2017 14:37:55

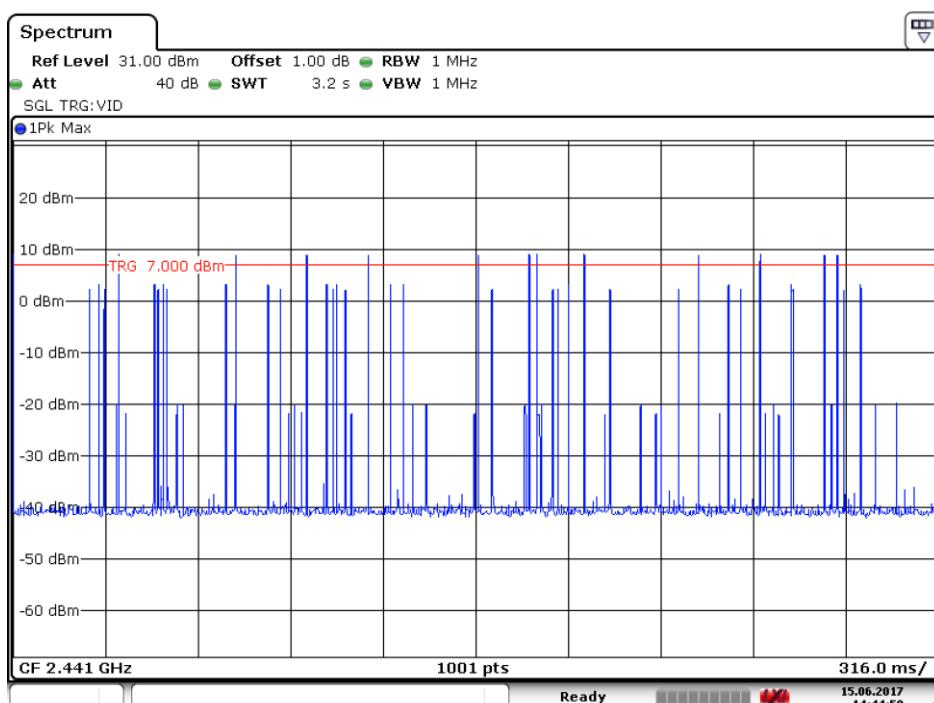


Date: 15.JUN.2017 14:46:00

Test Packet:	2-DH3
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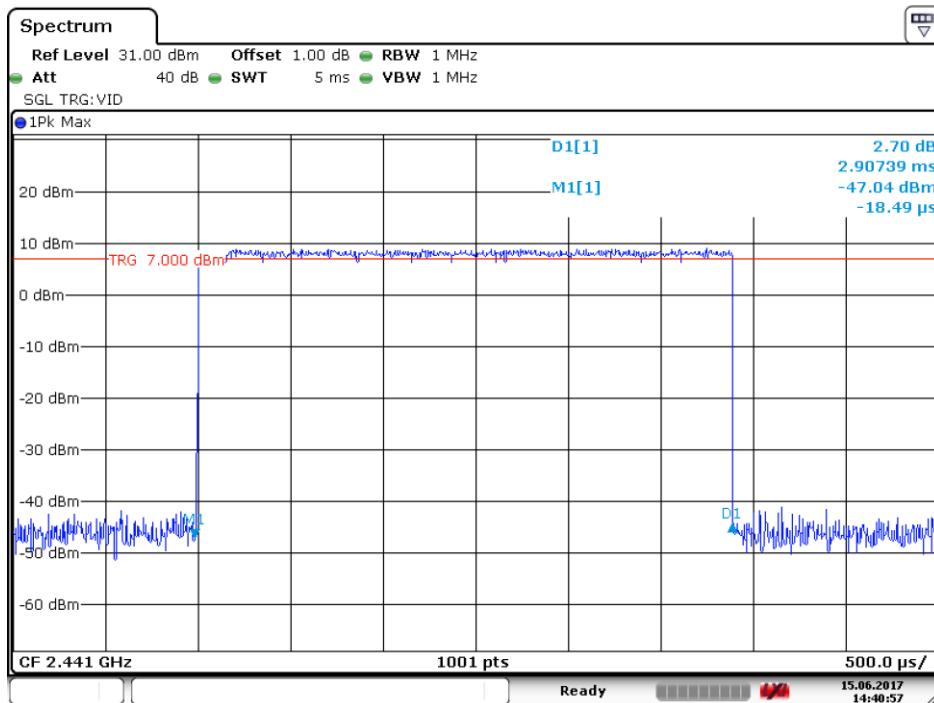


Date: 15.JUN.2017 14:39:45

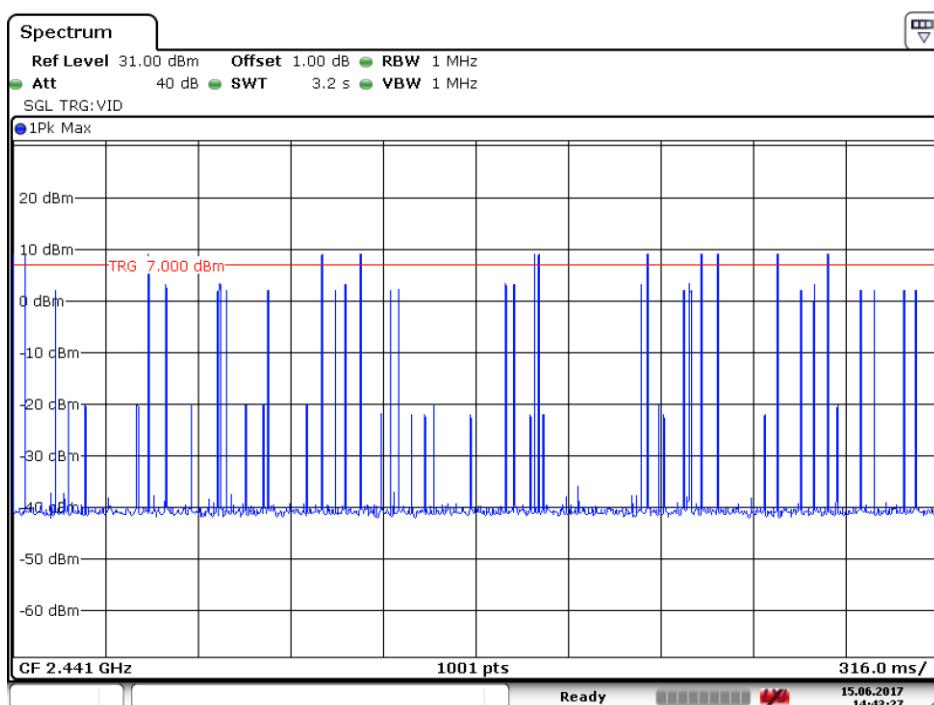


Date: 15.JUN.2017 14:44:49

Test Packet:	2-DH5
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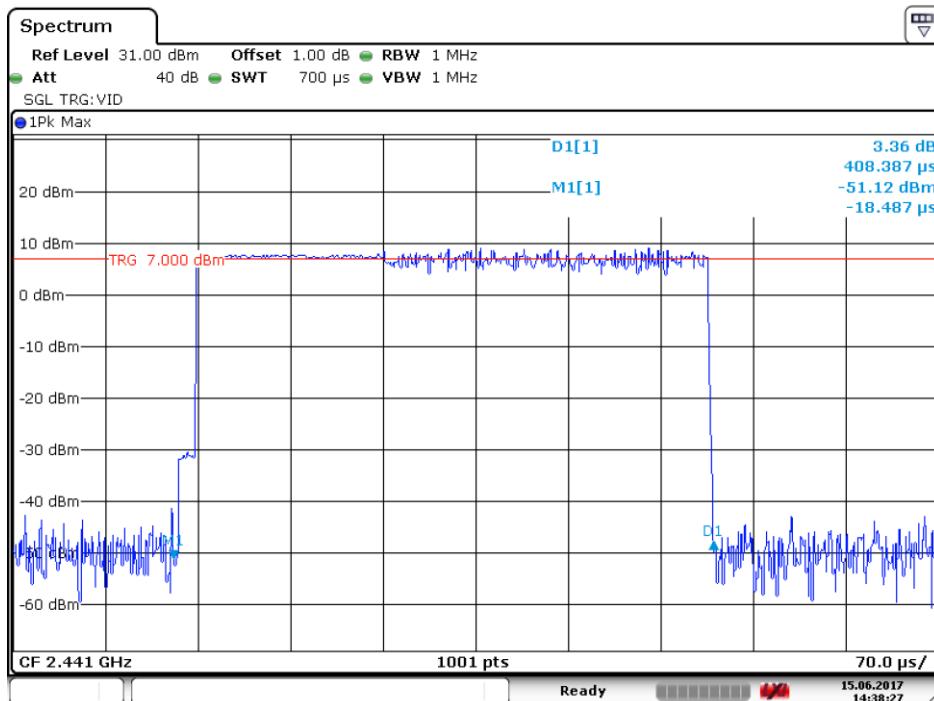


Date: 15.JUN.2017 14:40:58



Date: 15.JUN.2017 14:43:28

Test Packet:	3-DH1
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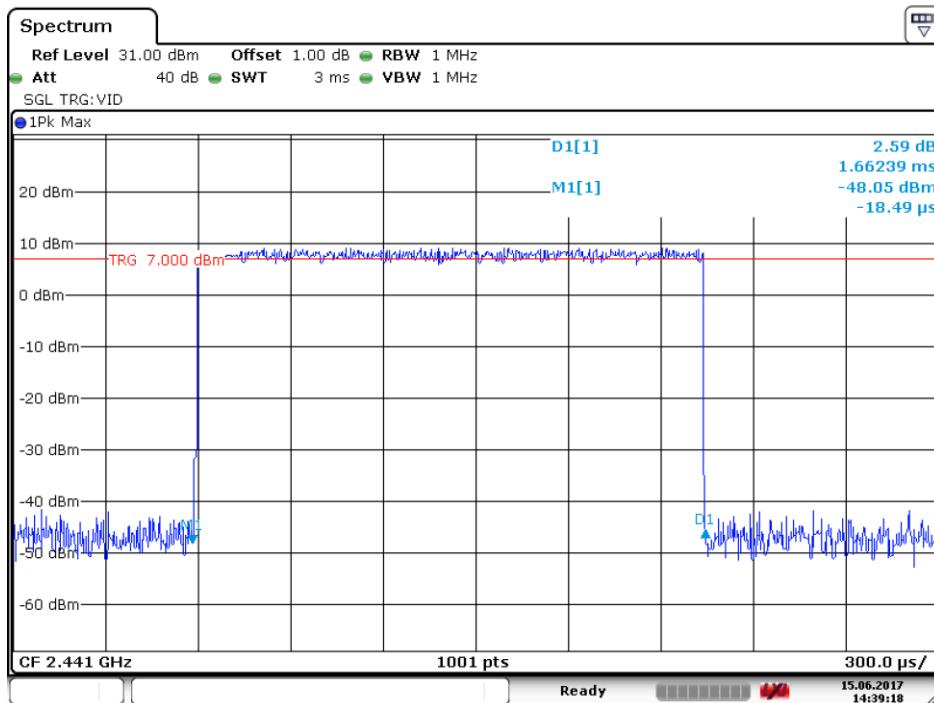


Date: 15.JUN.2017 14:38:28

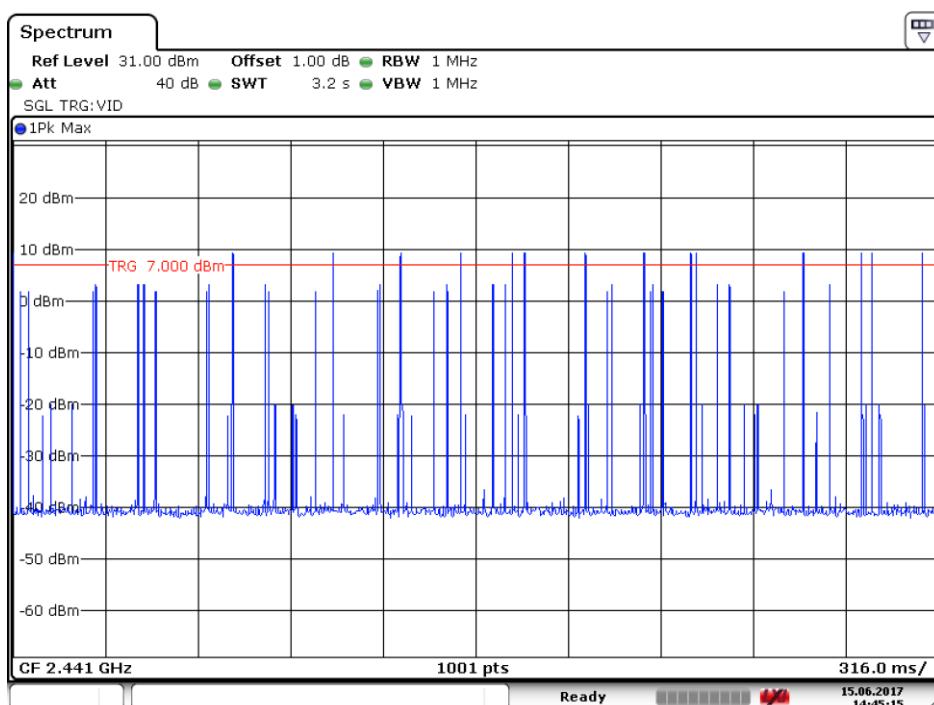


Date: 15.JUN.2017 14:45:39

Test Packet:	3-DH3
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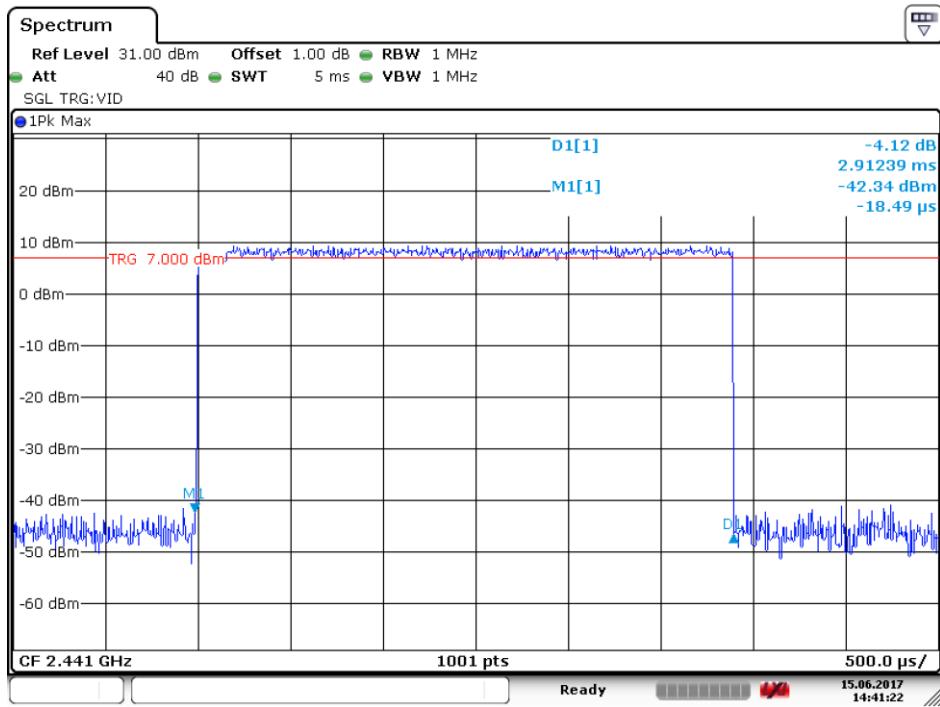


Date: 15.JUN.2017 14:39:18

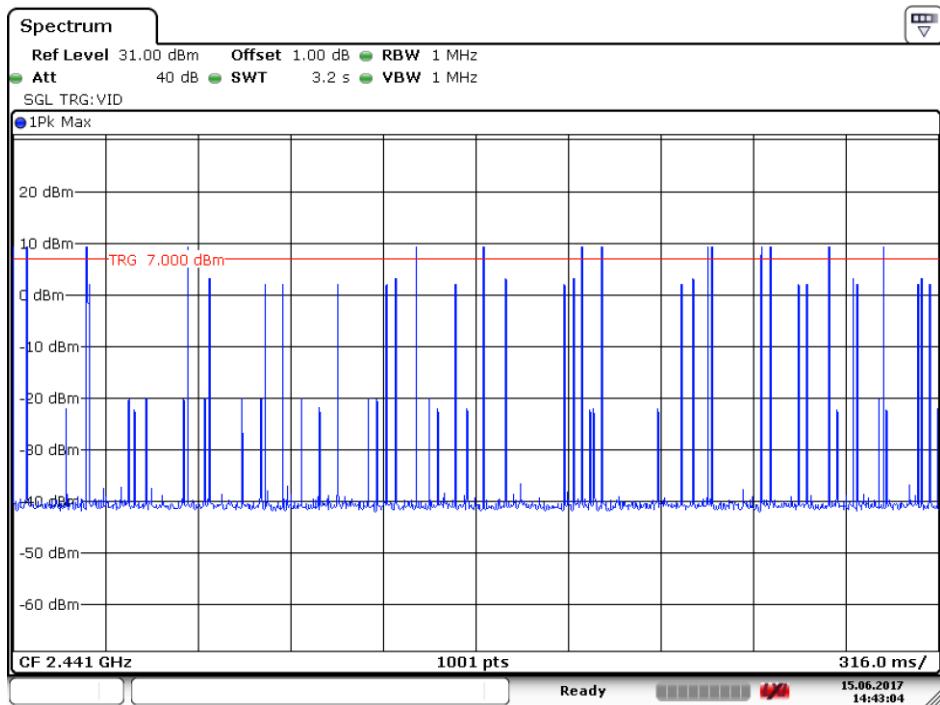


Date: 15.JUN.2017 14:45:15

Test Packet:	3-DH5
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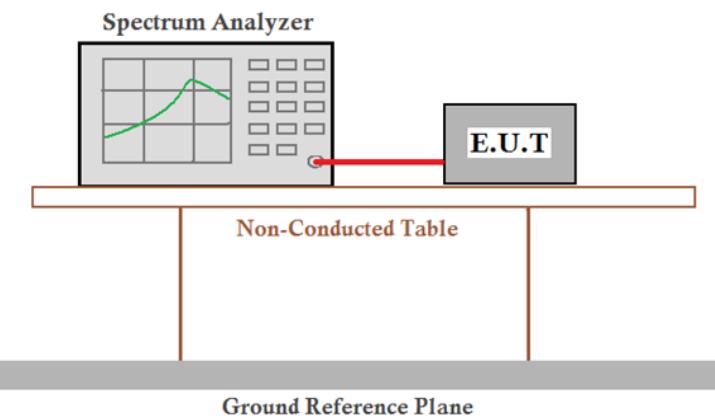


Date: 15.JUN.2017 14:41:22



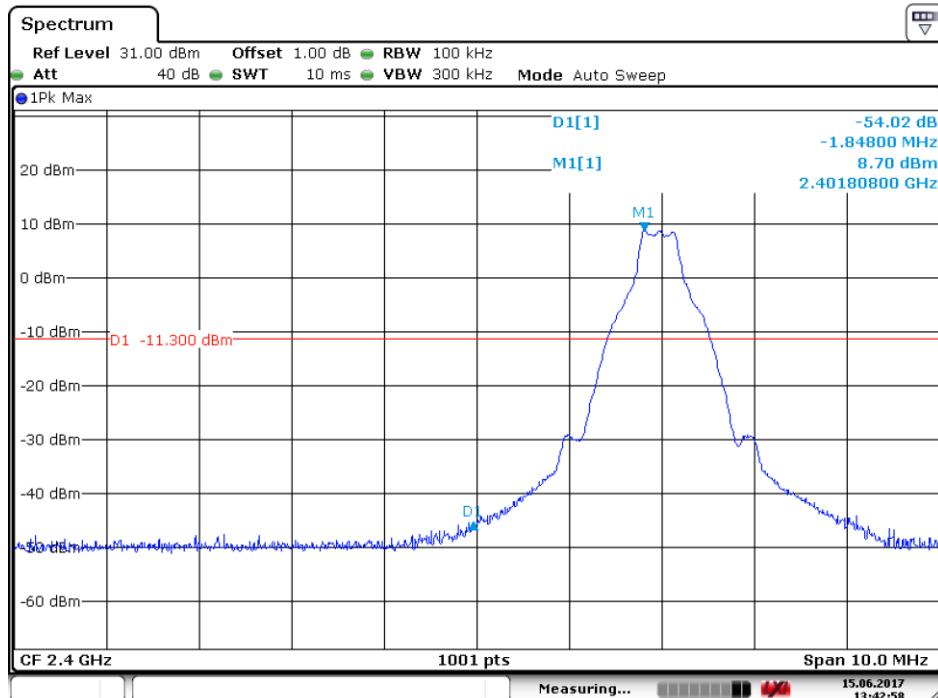
Date: 15.JUN.2017 14:43:05

6.8 Band-edge for RF Conducted Emissions

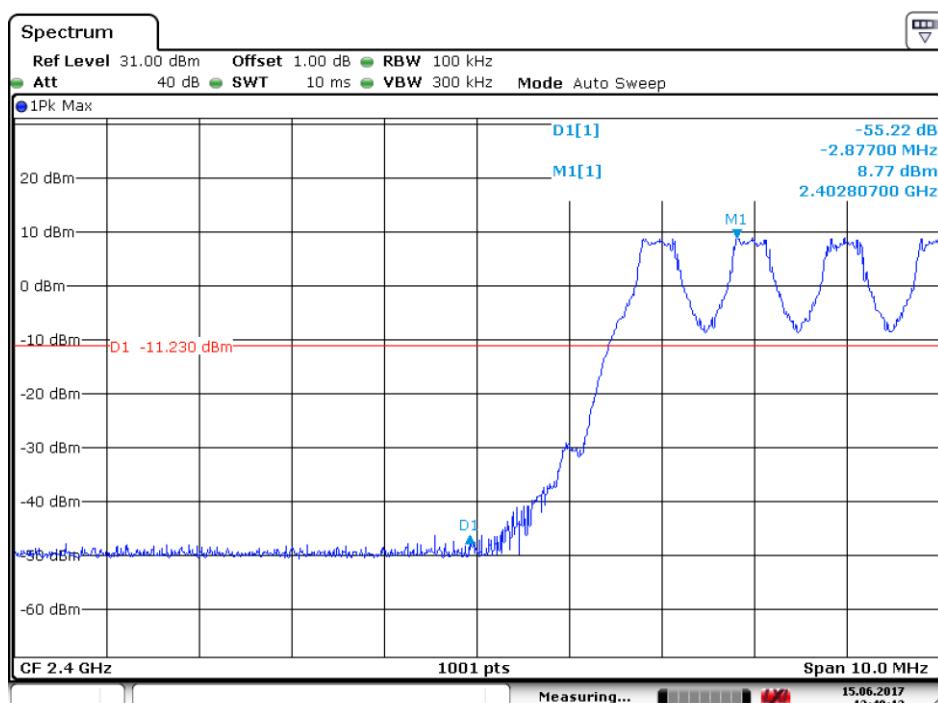
Test Requirement:	47 CFR Part 15C Section 15.247 (d)
Test Method:	ANSI C63.10:2013 Section 7.8.6
Test Setup:	
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.
Exploratory Test Mode:	Hopping and Non-hopping transmitting with all kind of modulation and all kind of data type
Final Test Mode:	Through Pre-scan, find the DH1 of data type is the worst case of GFSK modulation type, 2-DH1 of data type is the worst case of $\pi/4$ DQPSK modulation type, 3-DH1 of data type is the worst case of 8DPSK modulation type.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass

Test plot as follows:

Test mode:	GFSK	Test channel:	Lowest
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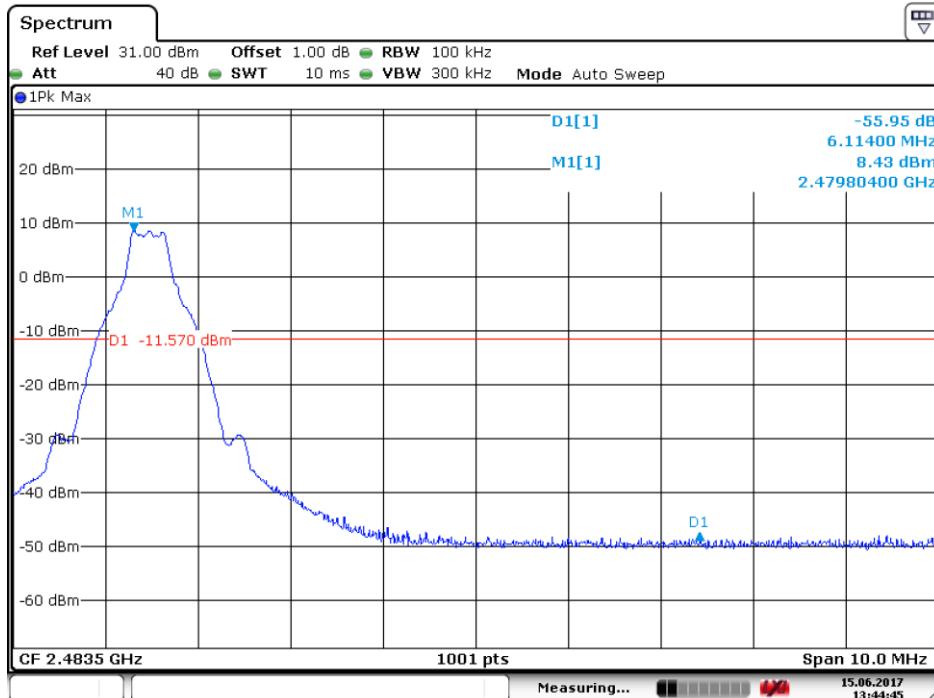


Date: 15.JUN.2017 13:42:59

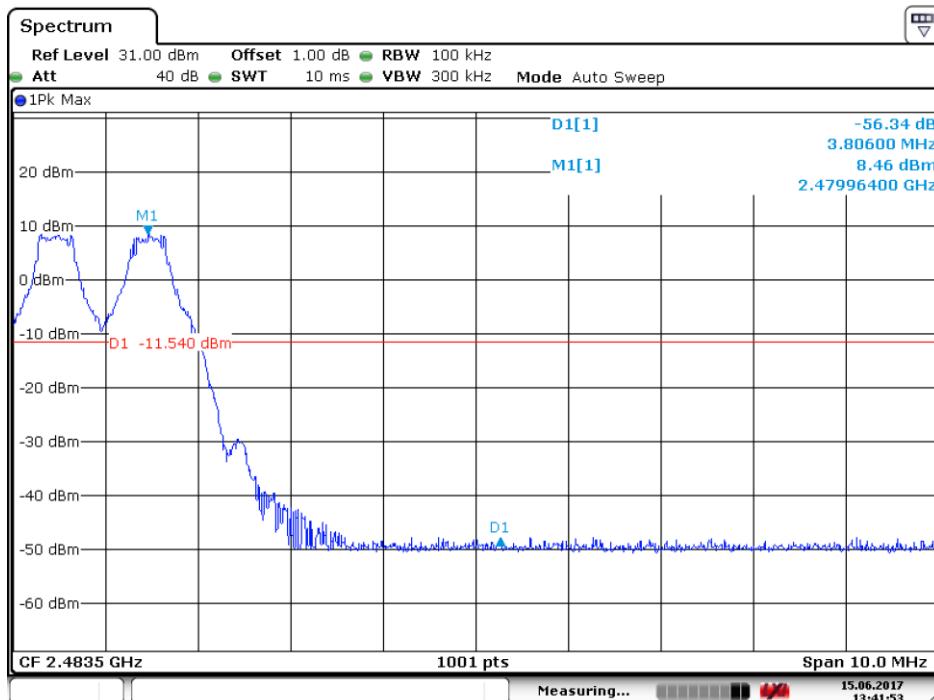


Date: 15.JUN.2017 13:40:13

Test mode:	GFSK	Test channel:	Highest
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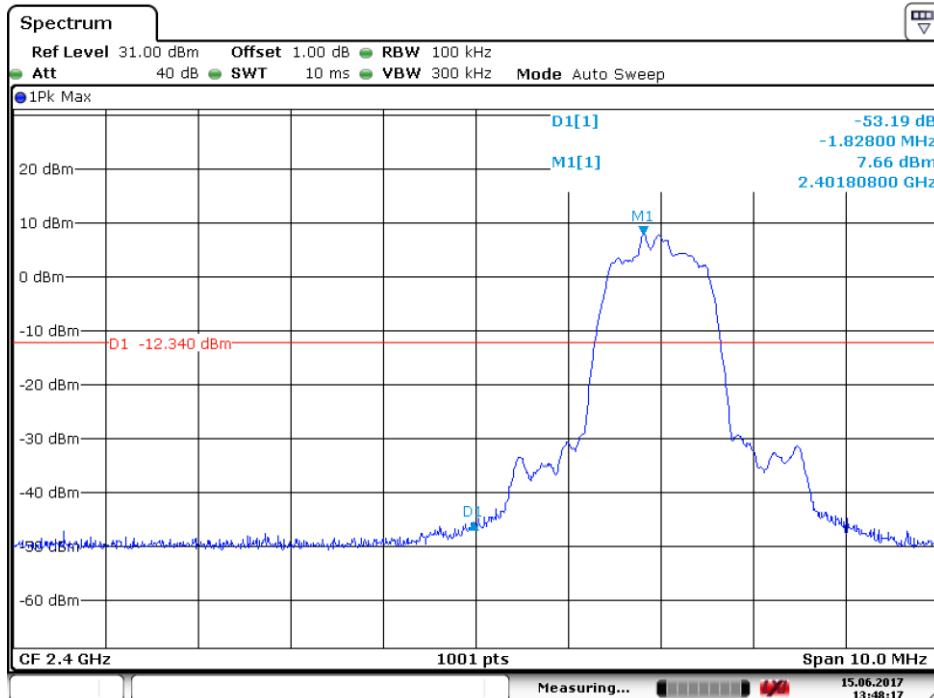


Date: 15.JUN.2017 13:44:46

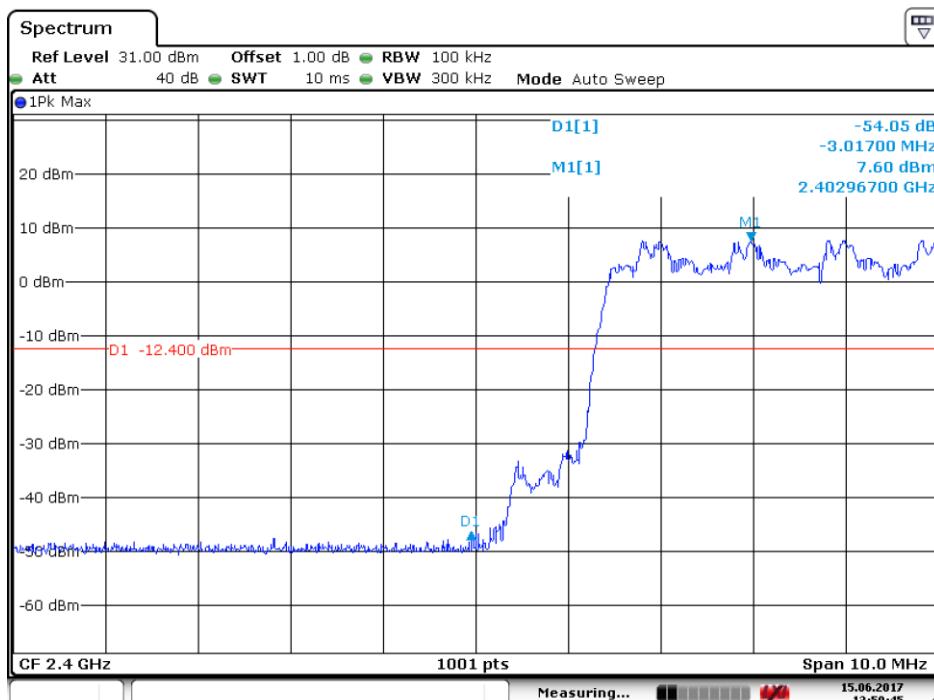


Date: 15.JUN.2017 13:41:54

Test mode:	π/4DQPSK	Test channel:	Lowest
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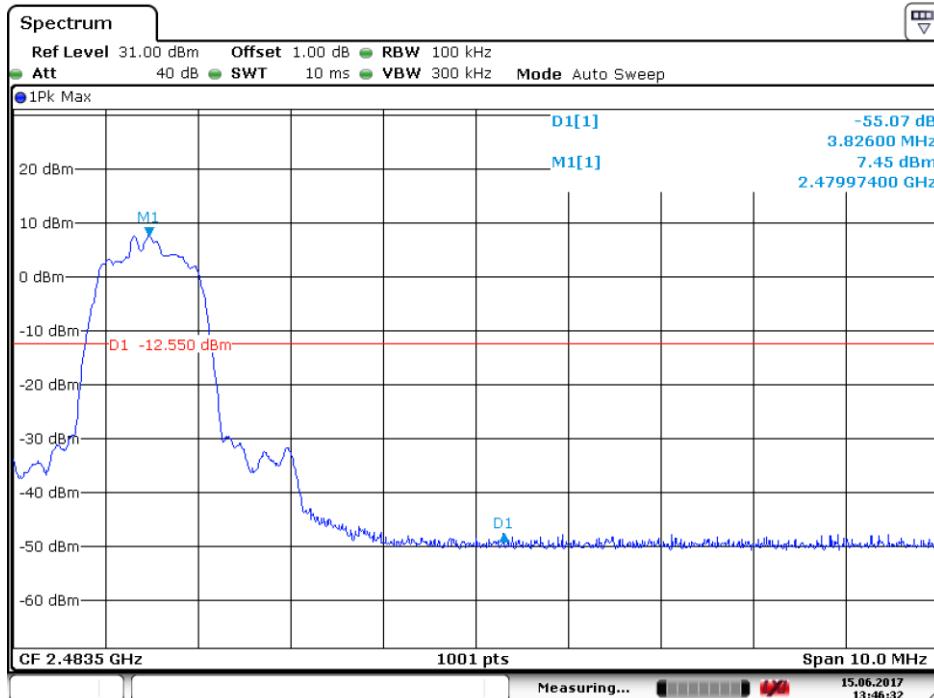


Date: 15.JUN.2017 13:48:17

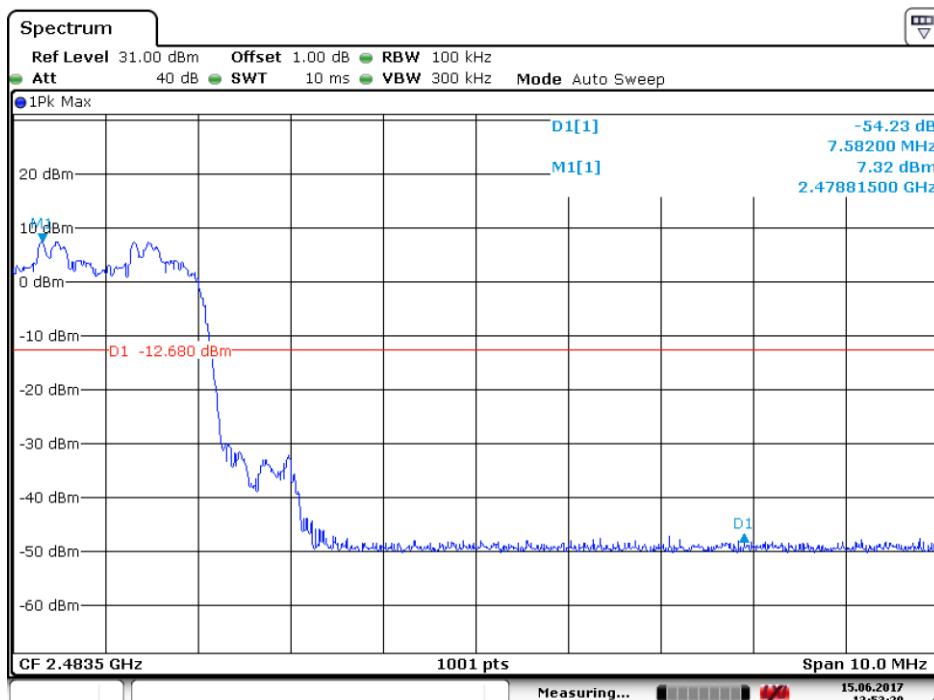


Date: 15.JUN.2017 13:50:45

Test mode:	π/4DQPSK	Test channel:	Highest
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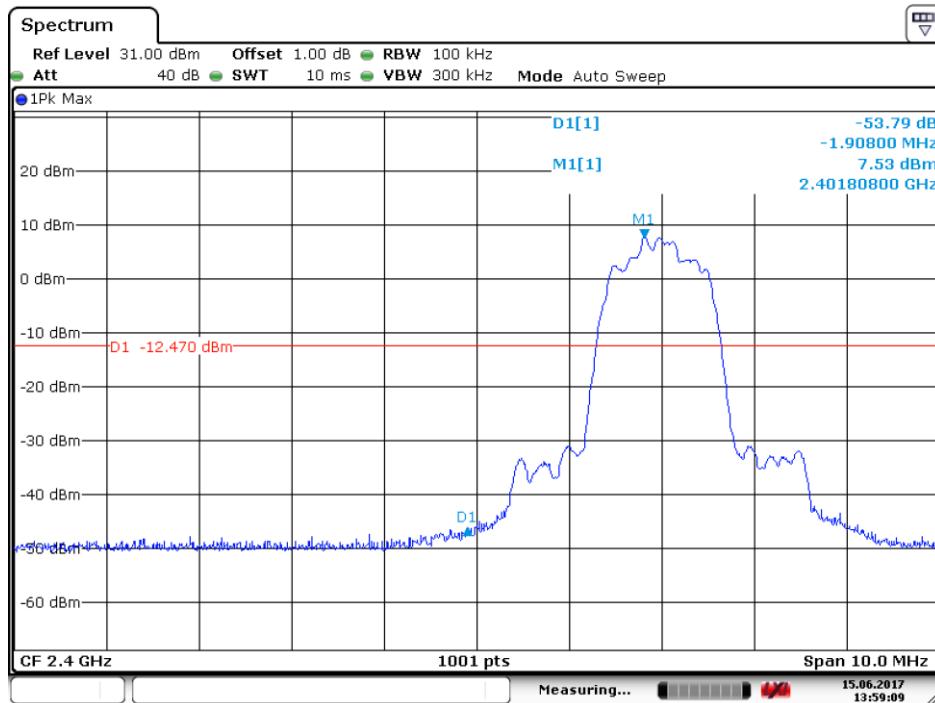


Date: 15.JUN.2017 13:46:33

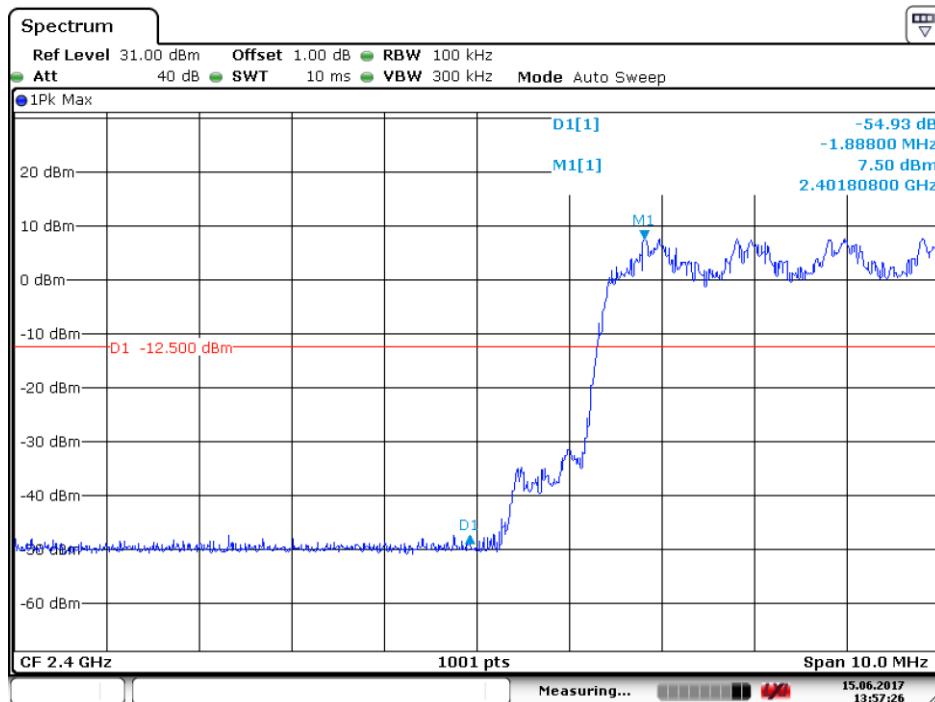


Date: 15.JUN.2017 13:53:30

Test mode:	8DPSK	Test channel:	Lowest
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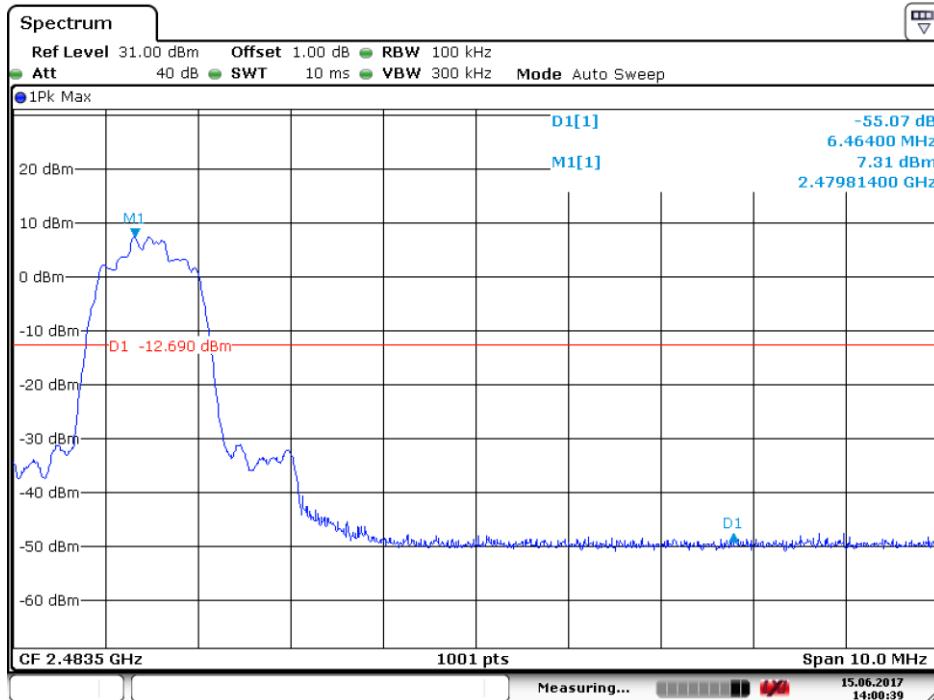


Date: 15.JUN.2017 13:59:09

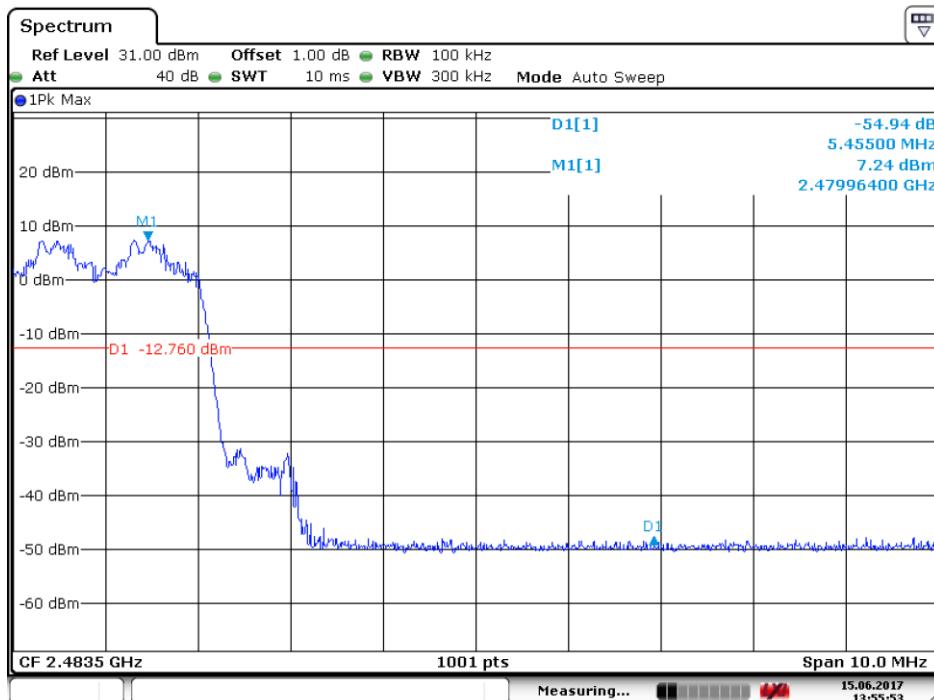


Date: 15.JUN.2017 13:57:27

Test mode:	8DPSK	Test channel:	Highest
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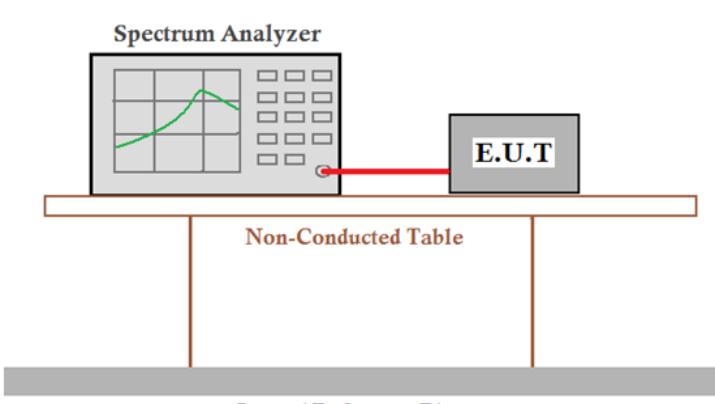


Date: 15.JUN.2017 14:00:40



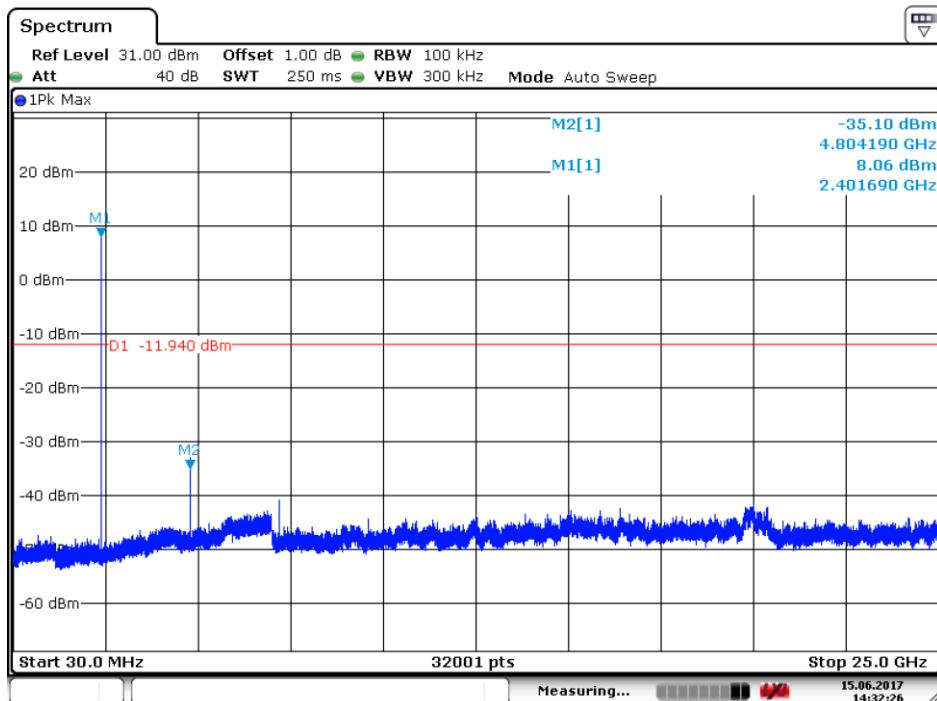
Date: 15.JUN.2017 13:55:54

6.9 Spurious RF Conducted Emissions

Test Requirement:	47 CFR Part 15C Section 15.247 (d)
Test Method:	ANSI C63.10:2013 Section 7.8.8
Test Setup:	
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type
Final Test Mode:	Through Pre-scan, find the DH1 of data type is the worst case of GFSK modulation type, 2-DH1 of data type is the worst case of $\pi/4$ DQPSK modulation type, 3-DH1 of data type is the worst case of 8DPSK modulation type.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass

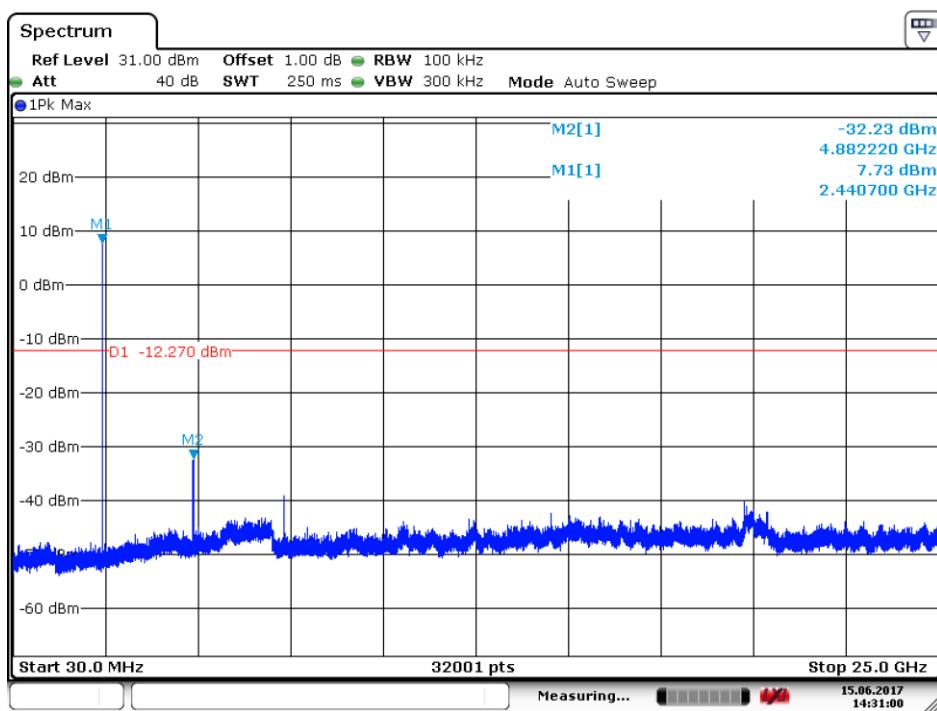
Test plot as follows:

Test mode:	GFSK	Test channel:	Lowest
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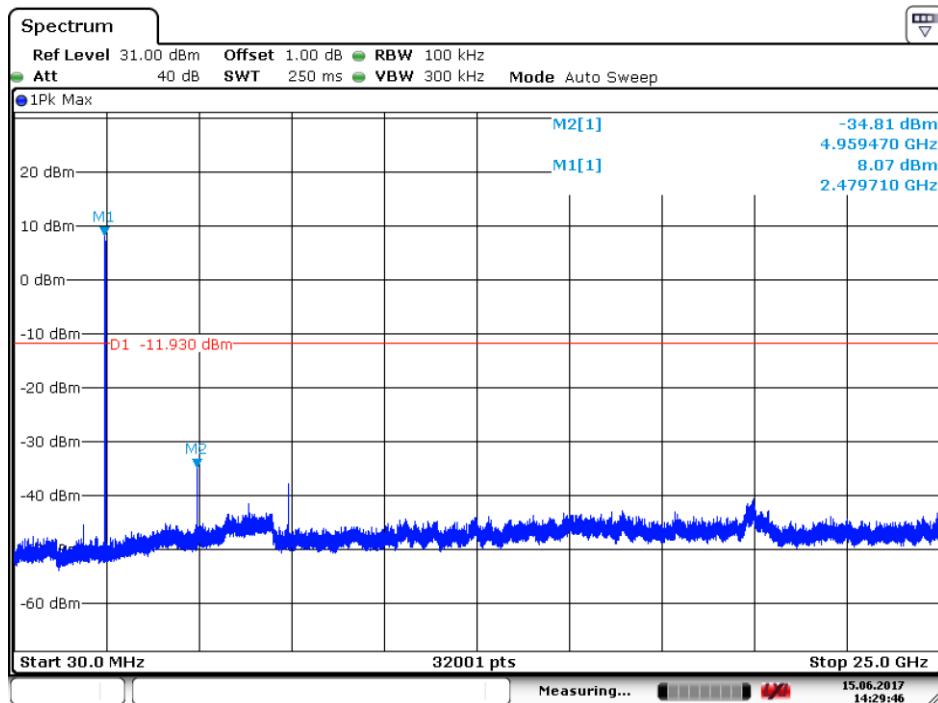
Date: 15.JUN.2017 14:32:27

Test mode:	GFSK	Test channel:	Middle
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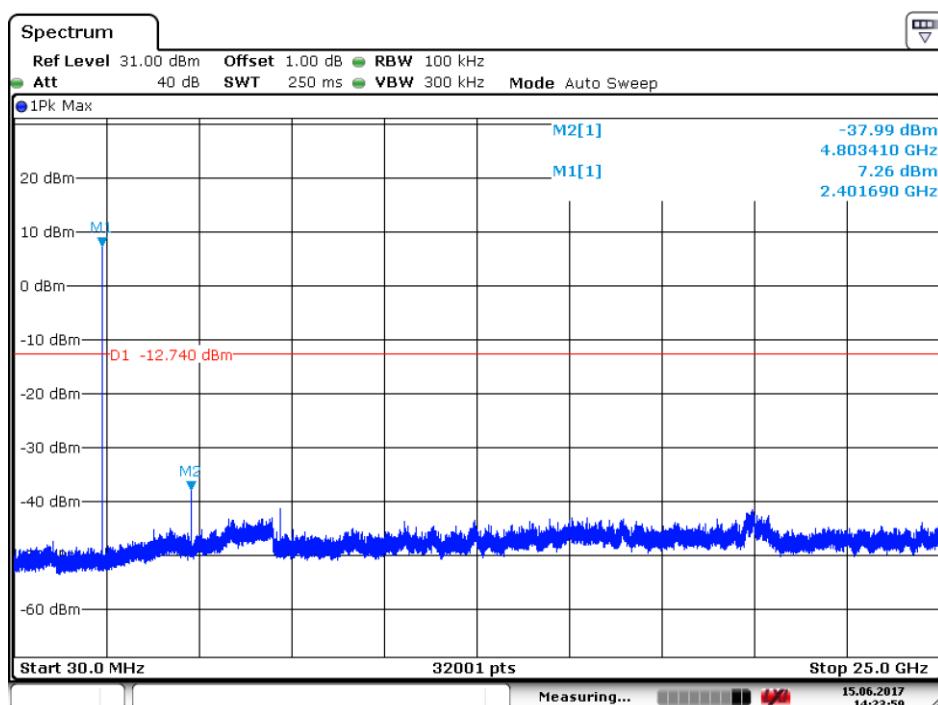
Date: 15.JUN.2017 14:31:00

Test mode:	GFSK	Test channel:	Highest
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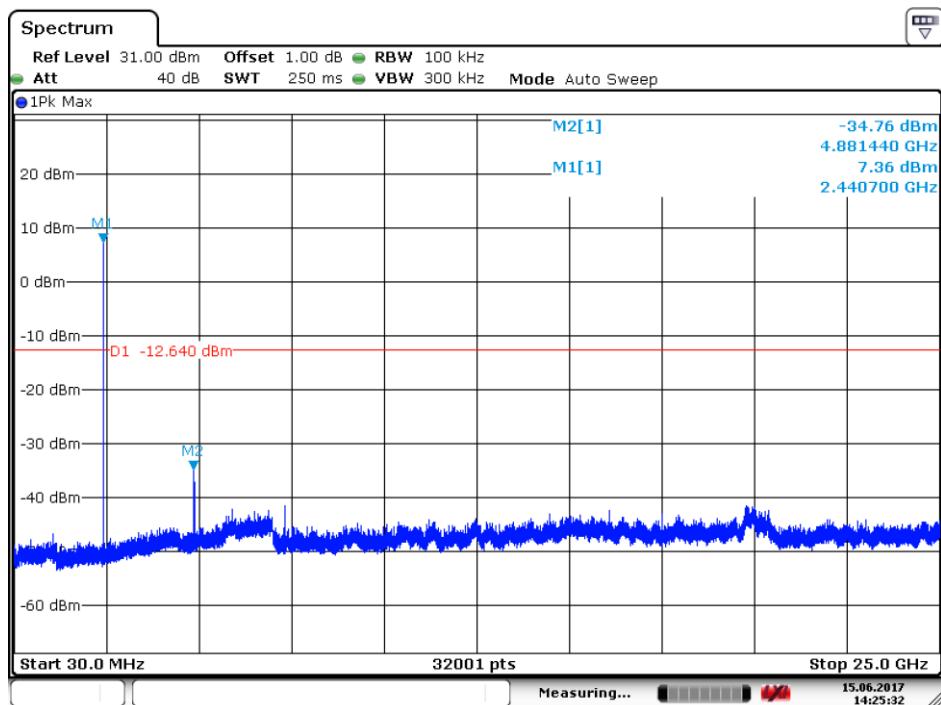
Date: 15.JUN.2017 14:29:46

Test mode:	TT/4DQPSK	Test channel:	Lowest
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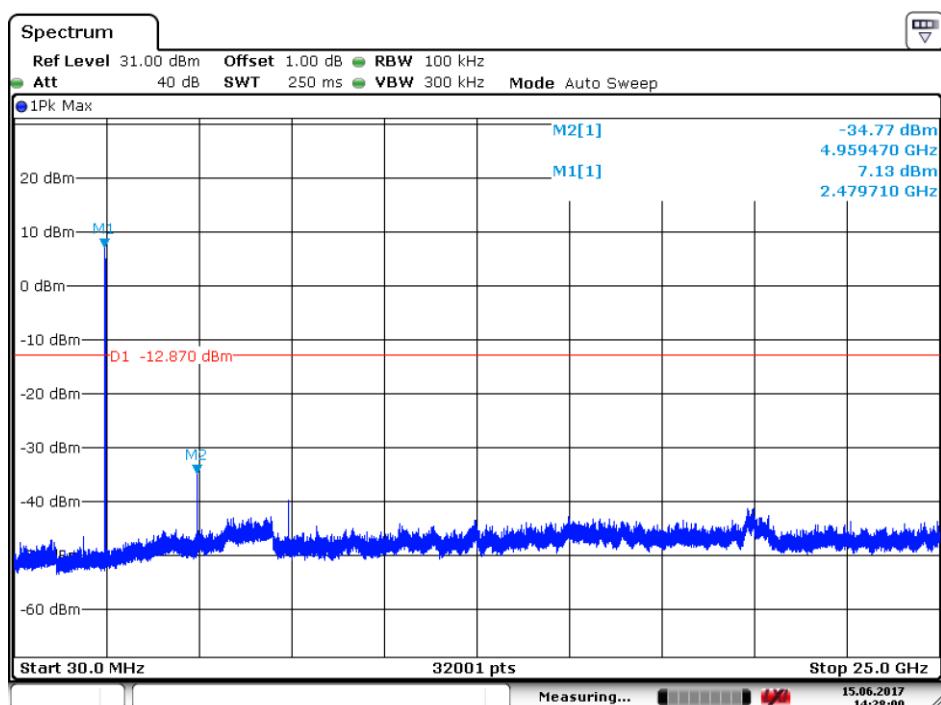
Date: 15.JUN.2017 14:23:59

Test mode:	π/4DQPSK	Test channel:	Middle
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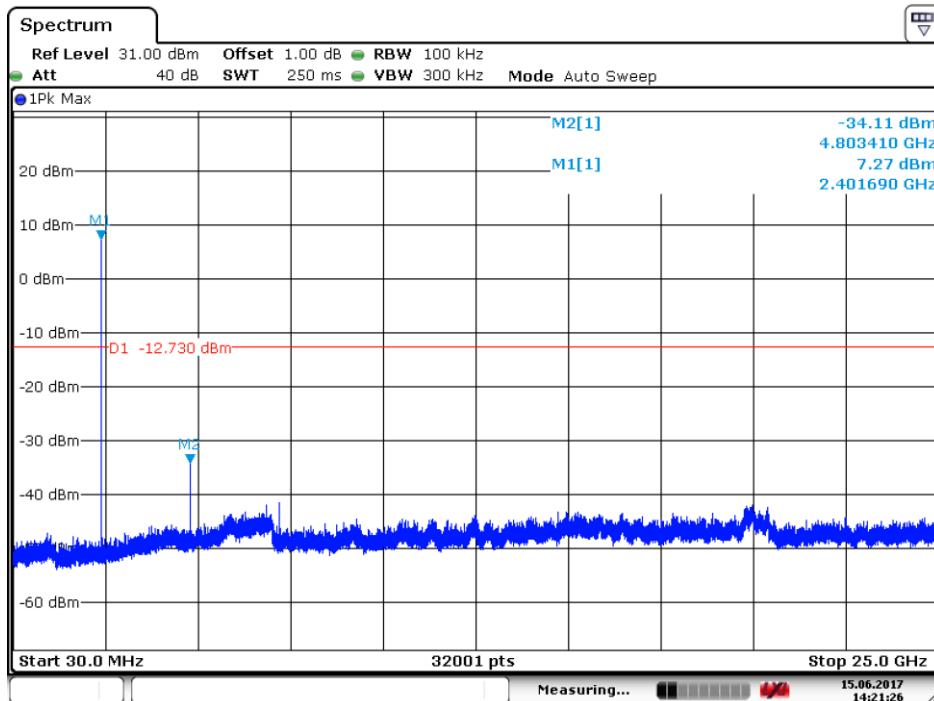
Date: 15.JUN.2017 14:25:32

Test mode:	π/4DQPSK	Test channel:	Highest
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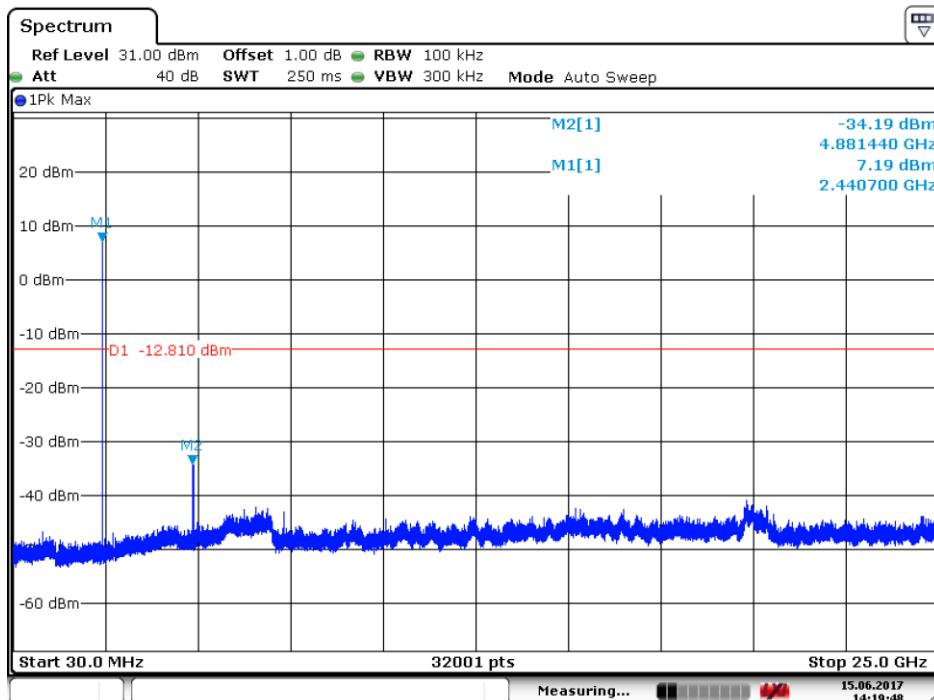
Date: 15.JUN.2017 14:28:00

Test mode:	8DPSK	Test channel:	Lowest
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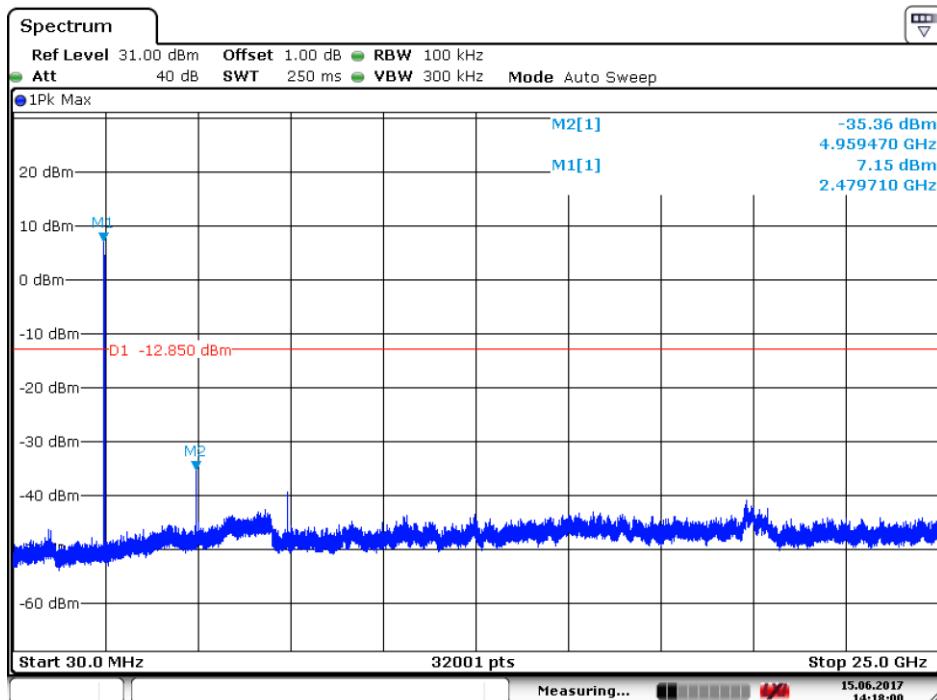
Date: 15.JUN.2017 14:21:27

Test mode:	8DPSK	Test channel:	Middle
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Date: 15.JUN.2017 14:19:49

Test mode:	8DPSK	Test channel:	Highest
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Date: 15.JUN.2017 14:18:01

Remark:

Scan from 9kHz to 25GHz, the disturbance below 30MHz was very low, and the above harmonics were the highest point could be found when testing, The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

Report No.: SZEM171001110305

Page: 61 of 72

6.10 Radiated Spurious Emission

Test Requirement:	47 CFR Part 15C Section 15.209 and 15.205				
Test Method:	ANSI C63.10: 2013				
Test Site:	Measurement Distance: 3m or 10m (Semi-Anechoic Chamber)				
Receiver Setup:	Frequency	Detector	RBW	VBW	Remark
	0.009MHz-0.090MHz	Peak	10kHz	30kHz	Peak
	0.009MHz-0.090MHz	Average	10kHz	30kHz	Average
	0.090MHz-0.110MHz	Quasi-peak	10kHz	30kHz	Quasi-peak
	0.110MHz-0.490MHz	Peak	10kHz	30kHz	Peak
	0.110MHz-0.490MHz	Average	10kHz	30kHz	Average
	0.490MHz-30MHz	Quasi-peak	10kHz	30kHz	Quasi-peak
	30MHz-1GHz	Quasi-peak	100 kHz	300kHz	Quasi-peak
	Above 1GHz	Peak	1MHz	3MHz	Peak
		Peak	1MHz	10Hz	Average
Limit:	Frequency	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz-0.490MHz	2400/F(kHz)	-	-	300
	0.490MHz-1.705MHz	24000/F(kHz)	-	-	30
	1.705MHz-30MHz	30	-	-	30
	30MHz-88MHz	100	40.0	Quasi-peak	3
	88MHz-216MHz	150	43.5	Quasi-peak	3
	216MHz-960MHz	200	46.0	Quasi-peak	3
	960MHz-1GHz	500	54.0	Quasi-peak	3
	Above 1GHz	500	54.0	Average	3

Note: 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

Test Setup:

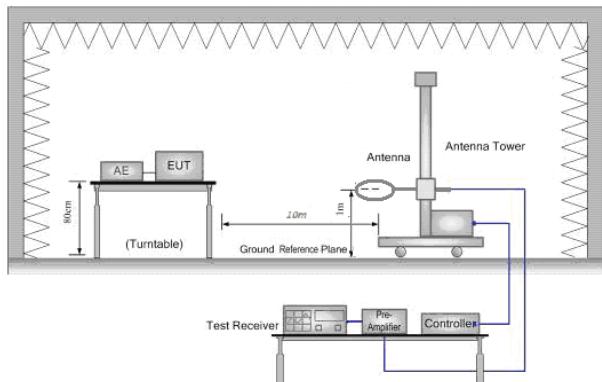


Figure 1. Below 30MHz

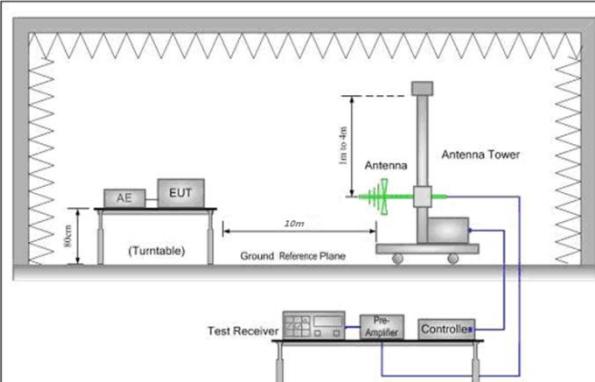


Figure 2. 30MHz to 1GHz

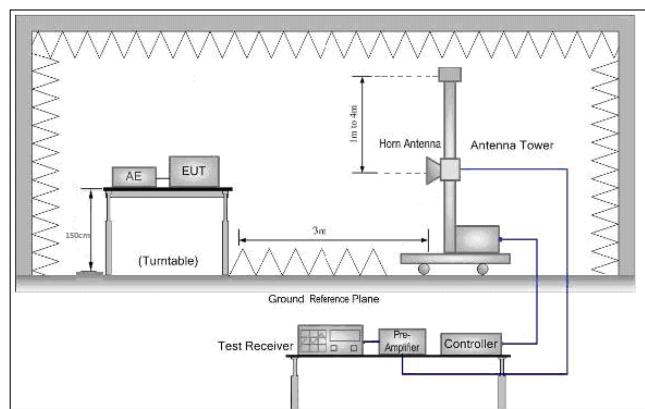
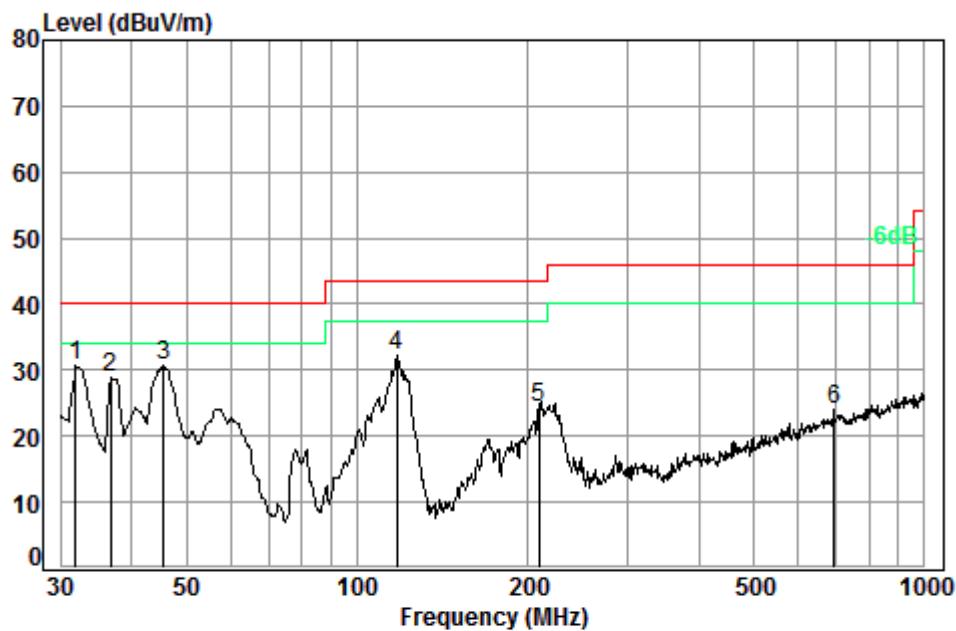


Figure 3. Above 1 GHz

Test Procedure:	<ul style="list-style-type: none">a. For below 1GHz, the EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.b. For above 1GHz, the EUT was placed on the top of a rotating table 1.5 meters above the ground at a 3 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.c. The EUT was set 3 or 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.d. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.e. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.f. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.g. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.h. Test the EUT in the lowest channel (2402MHz), the middle channel (2441MHz), the Highest channel (2480MHz)i. The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, and found the X axis positioning which it is the worst case.j. Repeat above procedures until all frequencies measured was complete.
Exploratory Test Mode:	Non-hopping transmitting mode with all kind of modulation and all kind of data type Charge + Transmitting mode.
Final Test Mode:	Through Pre-scan, find the DH1 of data type and GFSK modulation is the worst case. Pretest the EUT at Charge + Transmitting mode For below 1GHz part, through pre-scan, the worst case is the lowest channel. Only the worst case is recorded in the report.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass

6.10.1 Radiated Emission below 1GHz

30MHz~1GHz (QP)		
Test mode:	Charge + Transmitting	Vertical



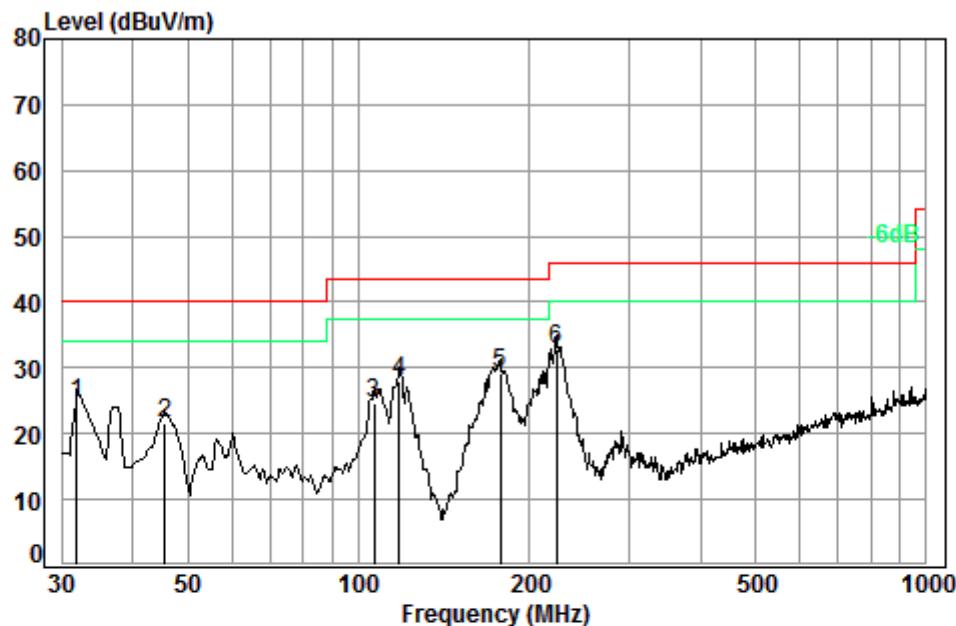
Condition: 3m VERTICAL

Job No. : 03519RG

Test mode: c

Freq	Cable	Ant	Preamp	Read	Limit	Over		
	Freq	Loss	Factor	Factor	Level	Level	Line	Limit
	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1	31.95	0.60	17.61	27.35	39.79	30.65	40.00	-9.35
2	36.77	0.60	14.91	27.33	40.58	28.76	40.00	-11.24
3 pp	45.53	0.72	10.66	27.30	46.59	30.67	40.00	-9.33
4	117.36	1.25	8.08	27.09	50.11	32.35	43.50	-11.15
5	209.31	1.46	10.68	26.66	38.90	24.38	43.50	-19.12
6	691.99	2.89	21.54	27.42	26.92	23.93	46.00	-22.07

Test mode:	Charge + Transmitting	Horizontal
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Condition: 3m HORIZONTAL

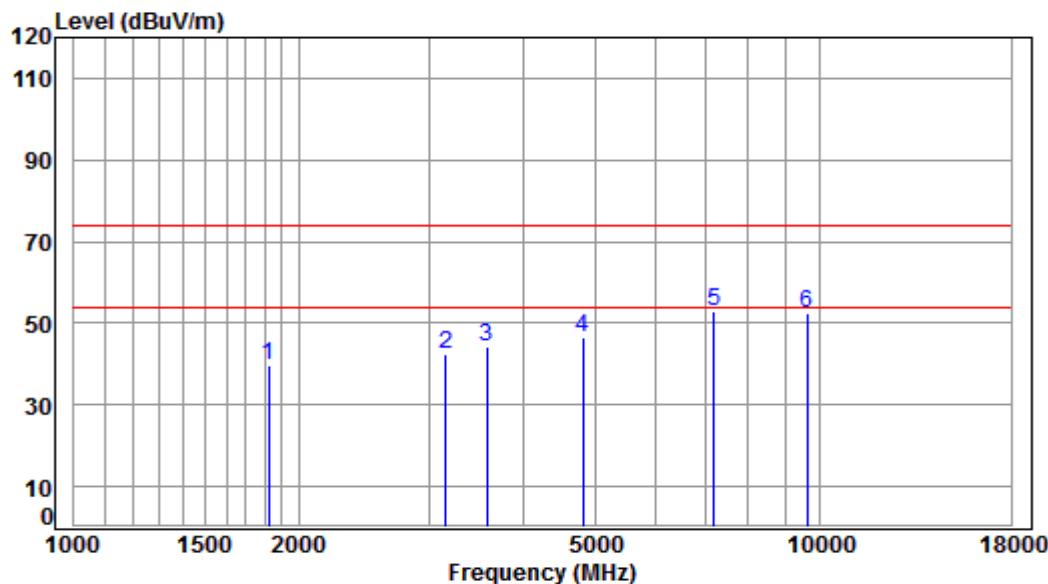
Job No. : 03519RG

Test mode: c

	Cable Freq	Loss MHz	Ant Factor	Preamp Factor	Read Level dB	Limit Level dBuV	Line Level dBuV/m	Over Line dBuV/m	Over Limit dB
1	31.95	0.60	17.61	27.35	33.76	24.62	40.00	-15.38	
2	45.53	0.72	10.66	27.30	37.44	21.52	40.00	-18.48	
3	106.76	1.22	8.76	27.15	41.95	24.78	43.50	-18.72	
4	118.19	1.25	8.03	27.08	45.84	28.04	43.50	-15.46	
5	177.51	1.37	9.80	26.78	44.90	29.29	43.50	-14.21	
6 pp	222.95	1.53	11.39	26.62	46.62	32.92	46.00	-13.08	

6.10.2 Transmitter Emission above 1GHz

Test mode:	GFSK (DH1)	Test channel:	Lowest	Remark:	Peak	Horizontal
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Condition: 3m HORIZONTAL

Job No : 11103RG

Mode : 2402 TX SE

Note : BT

Freq	Cable	Ant	Preamp	Read	Limit	Over	Remark	
	Loss	Factor	Factor	Level	Level	Line		
	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1	1824.302	5.09	27.16	41.60	49.18	39.83	74.00	-34.17 Peak
2	3150.237	6.13	31.59	42.14	47.03	42.61	74.00	-31.39 Peak
3	3577.463	6.55	32.43	42.24	47.48	44.22	74.00	-29.78 Peak
4	4804.000	7.89	34.16	42.47	46.92	46.50	74.00	-27.50 peak
5 pp	7206.000	10.08	36.42	40.71	47.20	52.99	74.00	-21.01 peak
6	9608.000	10.75	37.52	37.74	42.11	52.64	74.00	-21.36 peak



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

Report No.: SZEM171001110305

Page: 67 of 72

Remark:

1) The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows:

Final Test Level = Receiver Reading + Antenna Factor + Cable Factor – Preamplifier Factor

2) Scan from 9kHz to 25GHz, the disturbance above 13GHz and below 30MHz was very low, and the above harmonics were the highest point could be found when testing, so only the above harmonics had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

3) As shown in this section, for frequencies above 1GHz, the field strength limits are based on average limits. However, the peak field strength of any emission shall not exceed the maximum permitted average limits specified above by more than 20 dB under any condition of modulation. So, only the peak measurements were shown in the report.

6.11 Restricted bands around fundamental frequency

Test Requirement:	47 CFR Part 15C Section 15.209 and 15.205					
Test Method:	ANSI C63.10: 2013					
Test Site:	Measurement Distance: 3m or 10m (Semi-Anechoic Chamber)					
Limit:	Frequency	Limit (dBuV/m @3m)	Remark			
	30MHz-88MHz	40.0	Quasi-peak Value			
	88MHz-216MHz	43.5	Quasi-peak Value			
	216MHz-960MHz	46.0	Quasi-peak Value			
	960MHz-1GHz	54.0	Quasi-peak Value			
	Above 1GHz	54.0	Average Value			
		74.0	Peak Value			
Test Setup:						

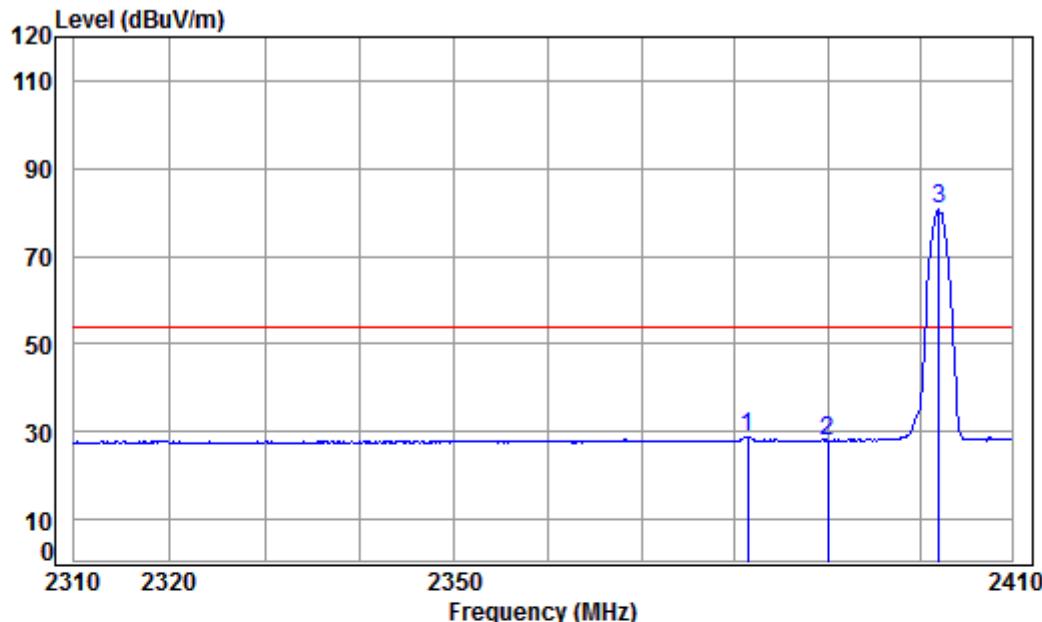
Figure 1. 30MHz to 1GHz

Figure 2. Above 1 GHz

Test Procedure:	<ul style="list-style-type: none">a. For below 1GHz, the EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.b. For above 1GHz, the EUT was placed on the top of a rotating table 1.5 meters above the ground at a 3 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.c. The EUT was set 3 or 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.d. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.e. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.f. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.g. Place a marker at the end of the restricted band closest to the transmit frequency to show compliance. Also measure any emissions in the restricted bands. Save the spectrum analyzer plot. Repeat for each power and modulation for lowest and highest channelh. Test the EUT in the lowest channel, the Highest channeli. The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, and found the X axis positioning which it is the worst case.j. Repeat above procedures until all frequencies measured was complete.
Exploratory Test Mode:	Non-hopping transmitting mode with all kind of modulation and all kind of data type Charge + Transmitting mode.
Final Test Mode:	Through Pre-scan, find the DH5 of data type and GFSK modulation is the worst case. Pretest the EUT at Charge + Transmitting mode, Only the worst case is recorded in the report.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass

Test plot as follows:

Worse case mode:	GFSK (DH5)	Test channel:	Lowest	Remark:	Average	Vertical
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Condition: 3m VERTICAL

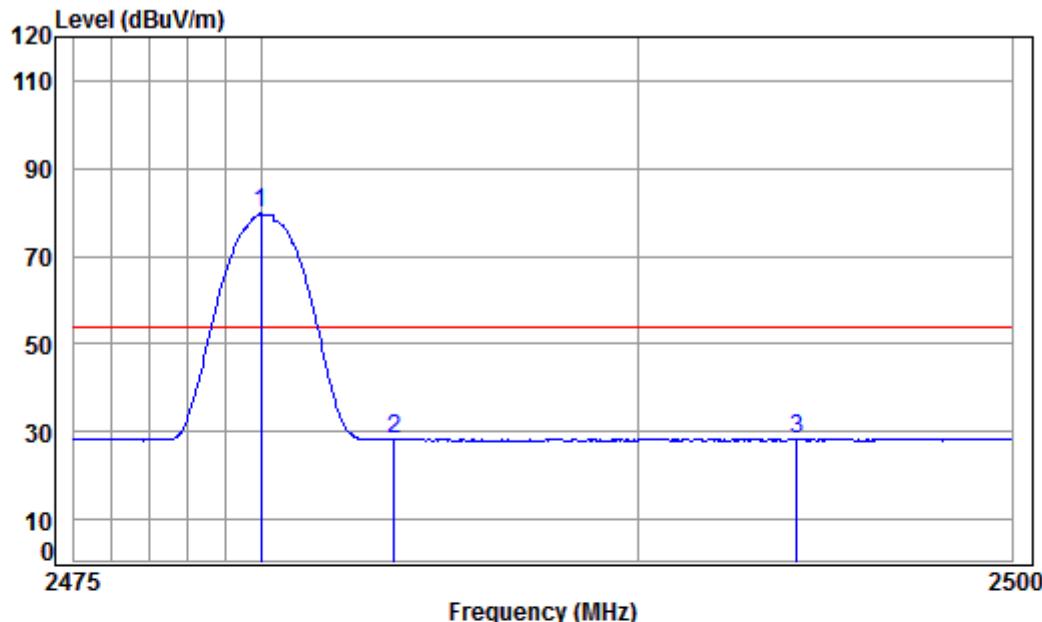
Job No : 11103RG

Mode : 2402 Band edge

Note : BT

Freq	Cable	Ant	Preamp	Read	Limit	Over	Remark
	Loss	Factor	Factor	Level	Level	Line	
MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1 2381.370	5.46	29.05	41.87	36.28	28.92	54.00	-25.08 Average
2 2390.000	5.47	29.08	41.87	35.37	28.05	54.00	-25.95 Average
3 pp 2402.047	5.49	29.11	41.88	88.23	80.95	54.00	26.95 Average

Worse case mode:	GFSK (DH5)	Test channel:	Highest	Remark:	Average	Vertical
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Condition: 3m VERTICAL

Job No : 11103RG

Mode : 2480 Band edge

Note : BT

	Cable	Ant	Preamp	Read	Limit	Over		
Freq	Loss	Factor	Factor	Level	Level	Line	Limit Remark	
	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1 pp	2479.955	5.59	29.34	41.91	86.66	79.68	54.00	25.68 Average
2	2483.500	5.60	29.35	41.91	35.20	28.24	54.00	-25.76 Average
3	2494.253	5.61	29.38	41.92	35.29	28.36	54.00	-25.64 Average



Note:

The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows:

Final Test Level = Receiver Reading + Antenna Factor + Cable Factor – Preamplifier Factor

7 Photographs - EUT Constructional Details

Refer to Appendix A - Photographs of EUT Constructional Details for SZEM1710011103RG